

Operational Amplifiers / Comparators



Ground Sense Low Voltage Operation CMOS Operational Amplifiers

BU7461G, BU7461SG, BU7441G, BU7441SG, BU7462F/FVM/NUX, BU7462SF/FVM/NUX, BU7442F/FVM/NUX, BU7442SF/FVM/NUX, BU7464F, BU7464SF, BU7444F, BU7444SF, BU7465HFV, BU7465SHFV, BU7445HFV, BU7445SHFV

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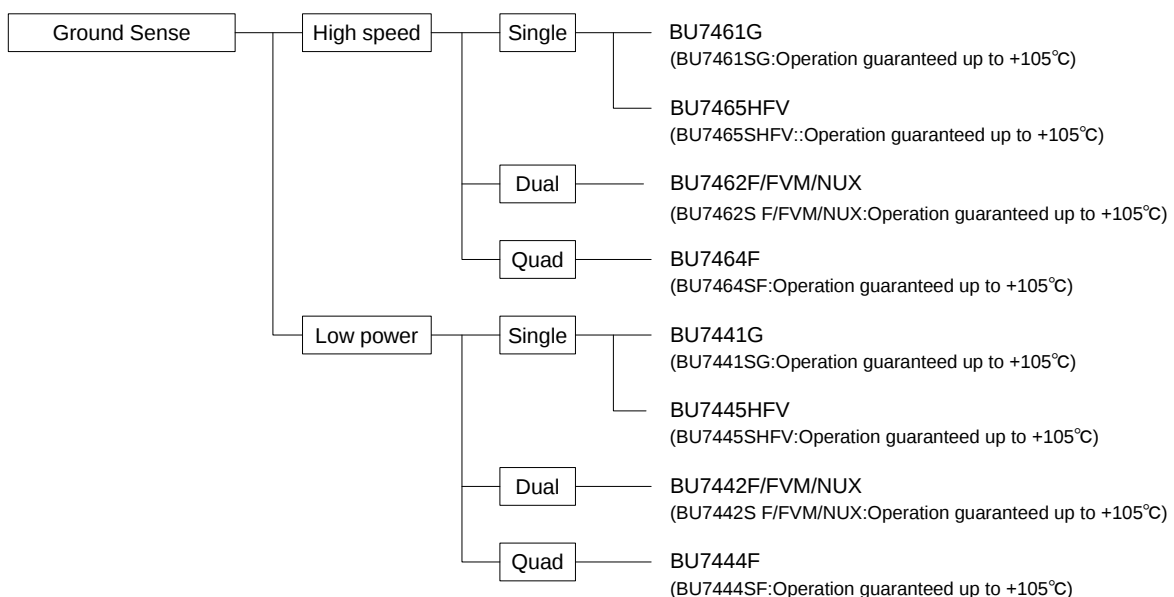
●Description

Low Voltage CMOS Op-Amp integrates one or two independent outputs full swing Op-Amps and phase compensation capacitors on a single chip. Especially, this series is operable with low voltage, low supply current and low input bias current.

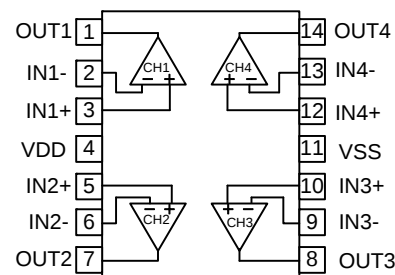
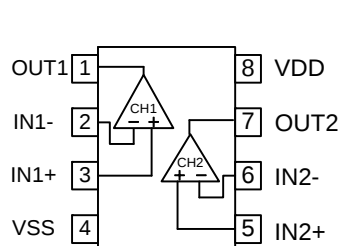
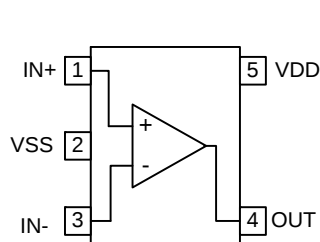
Ground Sense : BU7461 (BU7461S) family, BU7441 (BU7441S) family, BU7462 (BU7462S) family, BU7442 (BU7442S) family, BU7464 (BU7464S) family, BU7444 (BU7444S) family, BU7465 (BU7465S) family, BU7445 (BU7445S) family,

●Features

- 1) Operable with low voltage
+1.7[V] ~ +5.5[V] (Single supply) :
BU7461/BU7441 family, BU7462/BU7442 family
BU7464/BU7444 family, BU7465/BU7445 family
- 2) Input Ground Sense, Output Full Swing
- 3) High speed operation (BU7461 family, BU7462 family)
- 4) Internal phase compensation
- 5) Wide temperature range
-40[°C] ~ +85[°C]
(BU7461G, BU7462 family, BU7464F, BU7465HFV)
(BU7441G, BU7442 family, BU7444F, BU7445HFV)
-40[°C] ~ +105[°C]
(BU7461SG, BU7462S family, BU7464SF, BU7465SHFV)
(BU7441SG, BU7442S family, BU7444SF, BU7445SHFV)
- 6) High open loop voltage gain
- 7) Low supply current
(BU7441 family, BU7442 family)
(BU7445 family, BU7444 family)
- 8) Low input bias current 1[pA](Typ.)
- 9) ESD protection circuit
Human body mode (HBM) ± 4000 [V](Typ.)



●Pin Assignments



SSOP5

HVSOF5

SOP8

MSOP8

VSON008X2030

SOP14

Input type	Package					
	SSOP5	HVSOF5	SOP8	VSON008X2030	MSOP8	SOP14
Ground Sense	BU7461G BU7461SG BU7441G BU7441SG	BU7465HFV BU7465SHFV BU7445HFV BU7445SHFV	BU7462F BU7462SF BU7442F BU7442SF	BU7462NUX BU7462SNUX BU7442NUX BU7442SNUX	BU7462FVM BU7462SFVM BU7442FVM BU7442SFVM	BU7464F BU7464SF BU7444F BU7444SF

●Absolute maximum rating (Ta=25[°C])

Parameter	Symbol	Rating		Unit
		BU7461G, BU7462F/FVM/NUX BU7441G, BU7442F/FVM/NUX BU7464F, BU7444F BU7445HFV, BU7465HFV	BU7461SG, BU7462S F/FVM/NUX BU7441SG, BU7442S F/FVM/NUX BU7464SF, BU7444SF BU7445SHFV, BU7465SHFV	
Supply Voltage	VDD-VSS	+7		V
Differential Input Voltage ^(*1)	Vid	VDD-VSS		V
Input Common-mode Voltage Range	Vicm	(VSS-0.3) ~ (VDD+0.3)		V
Operating Temperature	Topr	-40 ~ +85	-40 ~ +105	°C
Storage Temperature	Tstg	-55 ~ +125		°C
Maximum Junction Temperature	Tjmax	+125		°C

Note: Absolute maximum rating item indicates the condition which must not be exceeded.

Application of voltage in excess of absolute maximum rating or use out absolute maximum rated temperature environment may cause deterioration of characteristics.

(*1) The voltage difference between inverting input and non-inverting input is the differential input voltage. Then input terminal voltage is set to more than VSS.

●Electrical characteristics

OBU7461 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7461G, BU7461SG				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*2)	Vio	25°C	-	1	6	mV	—
Input Offset Current ^(*2)	Iio	25°C	-	1	-	pA	—
Input Bias Current ^(*2)	Ib	25°C	-	1	-	pA	—
Supply Current ^(*3)	IDD	25°C	-	150	350	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	450		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	70	95	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^(*4)	IOH	25°C	4	8	-	mA	VDD-0.4[V]
Output Sink Current ^(*4)	IOL	25°C	6	12	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	1.0	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	1	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	50	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=1[Vp-p] f=1[kHz]

(*2) Absolute value

(*3) Full range: BU7461: Ta=-40[°C] to +85[°C] BU7461S: Ta=-40[°C] to +105[°C]

(*4) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.
 When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

OBU7462 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7462F/FVM/NUX BU7462S F/FVM/NUX				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*5)	Vio	25°C	-	1	6	mV	—
Input Offset Current ^(*5)	Iio	25°C	-	1	-	pA	—
Input Bias Current ^(*5)	Ib	25°C	-	1	-	pA	—
Supply Current ^(*6)	IDD	25°C	-	300	700	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	900		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	70	95	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^(*7)	IOH	25°C	4	8	-	mA	VDD-0.4[V]
Output Sink Current ^(*7)	IOL	25°C	6	12	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	1.0	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	1	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	50	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=1[Vp-p] , f=1[kHz]
Channel Separation	CS	25°C	-	100	-	dB	AV=40[dB]

(*5) Absolute value

(*6) Full range: BU7261, BU7262: Ta=-40[°C] to +85[°C] BU7462S: Ta=-40[°C] to +105[°C]

(*7) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.
 When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

OBU7464 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7464F BU7464SF				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*5)	Vio	25°C	-	1	6	mV	—
Input Offset Current ^(*5)	Iio	25°C	-	1	-	pA	—
Input Bias Current ^(*5)	Ib	25°C	-	1	-	pA	—
Supply Current ^(*6)	IDD	25°C	-	600	1400	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	1800		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	70	95	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^(*7)	IOH	25°C	4	8	-	mA	VDD-0.4[V]
Output Sink Current ^(*7)	IOL	25°C	6	12	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	1.0	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	1	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	50	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=0.8[Vp-p], f=1[kHz]
Channel Separation	CS	25°C	-	100	-	dB	AV=40[dB]

(*8) Absolute value

(*9) Full range: BU7464: Ta=-40[°C] to +85[°C] BU7464S: Ta=-40[°C] to +105[°C]

(*10) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

OBU7465 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7465HFV BU7465SHFV				
			Min.	Typ.	Max.		
Input Offset Voltage ^{(*)5}	Vio	25°C	-	1	6	mV	—
Input Offset Current ^{(*)5}	Iio	25°C	-	1	-	pA	—
Input Bias Current ^{(*)5}	Ib	25°C	-	1	-	pA	—
Supply Current ^{(*)6}	IDD	25°C	-	120	300	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	400		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	60	100	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^{(*)7}	IOH	25°C	4	8	-	mA	VDD-0.4[V]
Output Sink Current ^{(*)7}	IOL	25°C	9	18	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	1.0	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	1.2	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	60	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=0.8[Vp-p], f=1[kHz]

(*)11) Absolute value

(*)12) Full range: BU7465: Ta=-40[°C] to +85[°C] BU7465S: Ta=-40[°C] to +105[°C]

(*)13) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

OBU7441 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7441G, BU7441SG				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*14)	Vio	25°C	-	1	6	mV	—
Input Offset Current ^(*14)	Iio	25°C	-	1	-	pA	—
Input Bias Current ^(*14)	Ib	25°C	-	1	-	pA	—
Supply Current ^(*15)	IDD	25°C	-	50	120	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	240		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	70	95	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^(*16)	IOH	25°C	3	6	-	mA	VDD-0.4[V]
Output Sink Current ^(*16)	IOL	25°C	5	10	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	0.3	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	0.6	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	50	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=1[Vp-p], f=1[kHz]

(*14) Absolute value

(*15) Full range: BU7441: Ta=-40[°C] to +85[°C] BU7441S: Ta=-40[°C] to +105[°C]

(*16) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

OBU7442 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7442F/FVM/NUX BU7442S F/FVM/NUX				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*17)	Vio	25°C	-	1	6	mV	—
Input Offset Current ^(*17)	Iio	25°C	-	1	-	pA	—
Input Bias Current ^(*17)	Ib	25°C	-	1	-	pA	—
Supply Current ^(*18)	IDD	25°C	-	100	240	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	480		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	70	95	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^(*19)	IOH	25°C	3	6	-	mA	VDD-0.4[V]
Output Sink Current ^(*19)	IOL	25°C	5	10	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	0.3	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	0.6	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	50	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=1[Vp-p], f=1[kHz]
Channel Separation	CS	25°C	-	100	-	dB	AV=40[dB]

(*17) Absolute value

(*18) Full range: BU7442: Ta=-40[°C] to +85[°C] BU7442S: Ta=-40[°C] to +105[°C]

(*19) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

OBU7444 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7444F, BU7444SF				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*20)	Vio	25°C	-	1	6	mV	—
Input Offset Current ^(*20)	Iio	25°C	-	1	-	pA	—
Input Bias Current ^(*20)	Ib	25°C	-	1	-	pA	—
Supply Current ^(*21)	IDD	25°C	-	200	480	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	960		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	70	95	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^(*22)	IOH	25°C	3	6	-	mA	VDD-0.4[V]
Output Sink Current ^(*22)	IOL	25°C	5	10	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	0.3	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	0.6	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	50	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=0.8[Vp-p], f=1[kHz]
Channel Separation	CS	25°C	-	100	-	dB	AV=40[dB]

(*20) Absolute value

(*21) Full range: BU7444: Ta=-40[°C] to +85[°C] BU7444S: Ta=-40[°C] to +105[°C]

(*22) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

OBU7445 family (Unless otherwise specified VDD=+3[V], VSS=0[V], Ta=25[°C])

Parameter	Symbol	Temperature Range	Limits			Unit	Condition
			BU7445HFV, BU7445SHFV				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*23)	Vio	25°C	-	1	6	mV	—
Input Offset Current ^(*23)	Iio	25°C	-	1	-	pA	—
Input Bias Current ^(*23)	Ib	25°C	-	1	-	pA	—
Supply Current ^(*24)	IDD	25°C	-	40	90	μA	RL=∞ All Op-Amps AV=0[dB], VIN=0.9[V]
		Full range	-	-	120		
High Level Output Voltage	VOH	25°C	VDD-0.1	-	-	V	RL=10[kΩ]
Low Level Output Voltage	VOL	25°C	-	-	VSS+0.1	V	RL=10[kΩ]
Large Signal Voltage Gain	AV	25°C	60	100	-	dB	RL=10[kΩ]
Input Common-mode Voltage Range	Vicm	25°C	0	-	1.8	V	VSS ~ VDD-1.2[V]
Common-mode Rejection Ratio	CMRR	25°C	45	60	-	dB	—
Power Supply Rejection Ratio	PSRR	25°C	60	80	-	dB	—
Output Source Current ^(*25)	IOH	25°C	4	8	-	mA	VDD-0.4[V]
Output Sink Current ^(*25)	IOL	25°C	9	18	-	mA	VSS+0.4[V]
Slew Rate	SR	25°C	-	0.25	-	V/μs	CL=25[pF]
Gain Band width	FT	25°C	-	0.4	-	MHz	CL=25[pF], AV=40[dB]
Phase Margin	θ	25°C	-	60	-	°	CL=25[pF], AV=40[dB]
Total Harmonic Distortion	THD	25°C	-	0.05	-	%	VOUT=0.8[Vp-p], f=1[kHz]

(*23) Absolute value

(*24) Full range: BU7445: Ta=-40[°C] to +85[°C] BU7445S: Ta=-40[°C] to +105[°C]

(*25) Under the high temperature environment, consider the power dissipation of IC when selecting the output current.

When the terminal short circuits are continuously output, the output current is reduced to climb to the temperature inside IC.

●Reference data (BU7461 family)

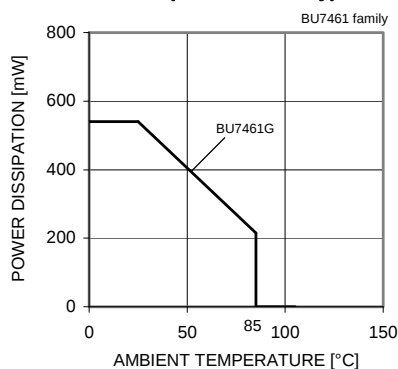


Fig.1
Derating curve

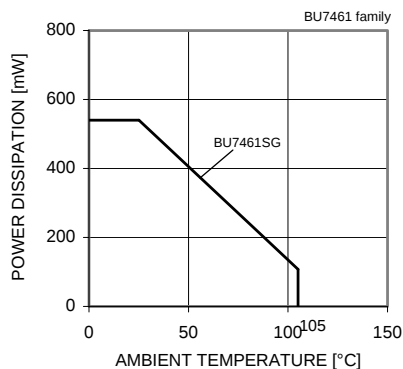


Fig.2
Derating curve

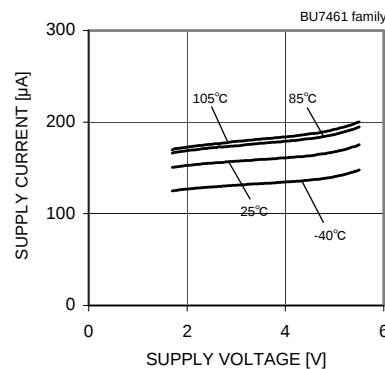


Fig.3
Supply Current – Supply Voltage

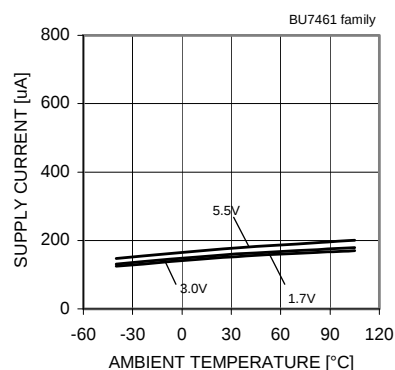


Fig.4
Supply Current – Ambient Temperature

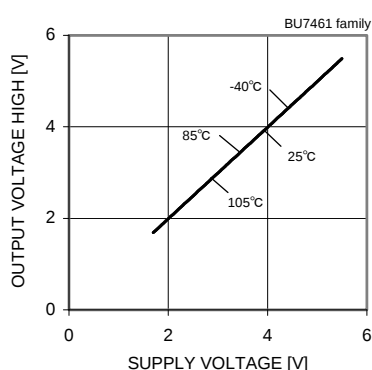


Fig.5
Output Voltage High – Supply Voltage
($R_L=10[k\Omega]$)

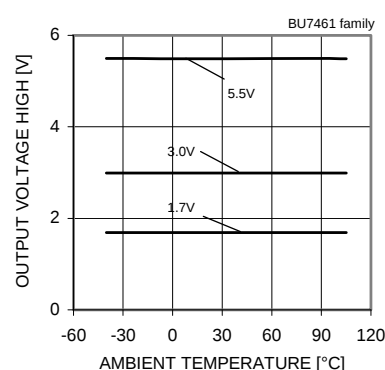


Fig.6
Output Voltage High – Ambient Temperature
($R_L=10[k\Omega]$)

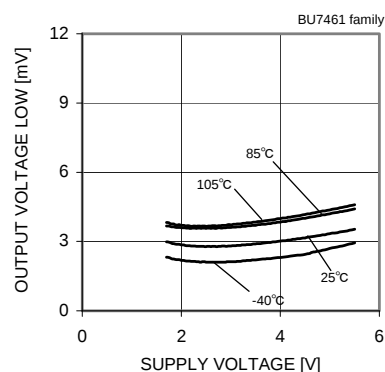


Fig.7
Output Voltage Low – Supply Voltage
($R_L=10[k\Omega]$)

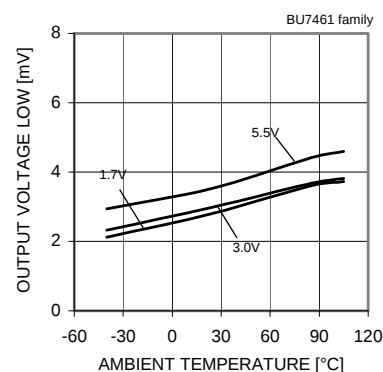


Fig.8
Output Voltage Low – Ambient Temperature
($R_L=10[k\Omega]$)

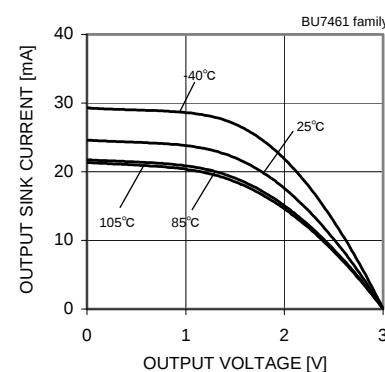


Fig.9
Output Source Current – Output Voltage
($V_{DD}=3.0[V]$)

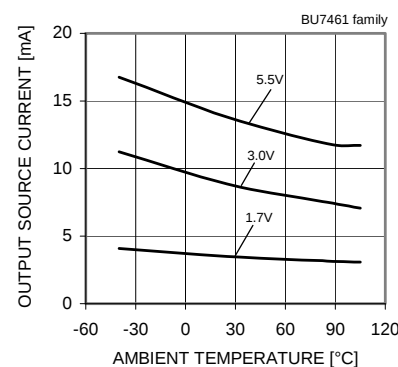


Fig.10
Output Source Current – Ambient Temperature
($V_{OUT}=V_{DD}-0.4[V]$)

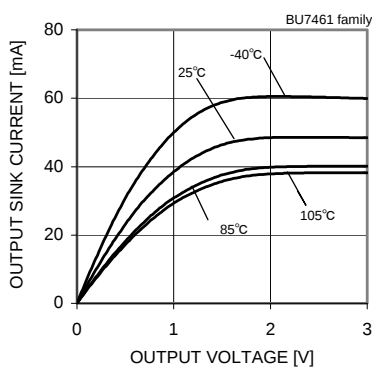


Fig.11
Output Sink Current – Output Voltage
($V_{DD}=3[V]$)

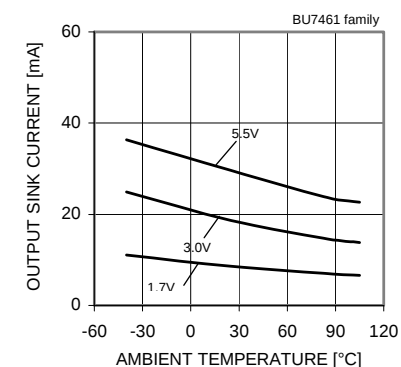


Fig.12
Output Sink Current – Ambient Temperature
($V_{OUT}=V_{SS}+0.4[V]$)

(*)The above data is ability value of sample, it is not guaranteed. BU7461G: -40[°C] ~ +85[°C] BU7461SG: -40[°C] ~ +105[°C]

●Reference data (BU7461 family)

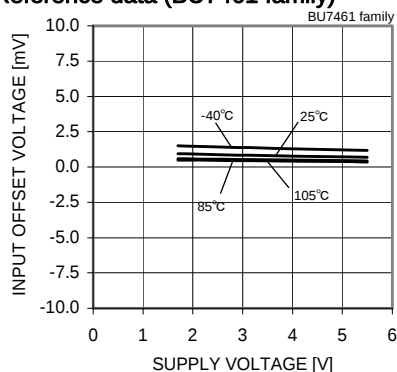


Fig.13
Input Offset Voltage – Supply Voltage
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

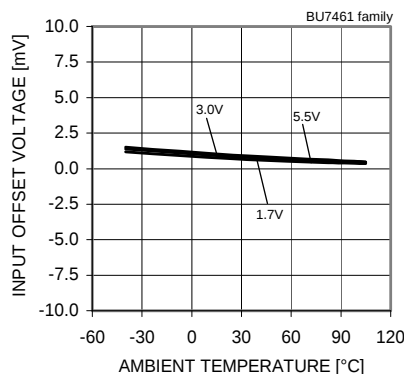


Fig.14
Input Offset Voltage – Ambient Temperature
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

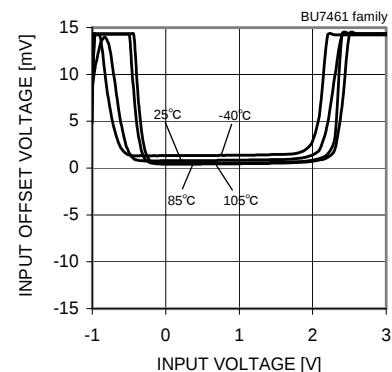


Fig.15
Input Offset Voltage – Input Voltage
($V_{DD} = 3[V]$)

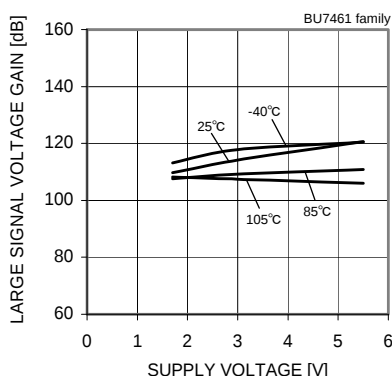


Fig.16
Large Signal Voltage Gain
– Supply Voltage

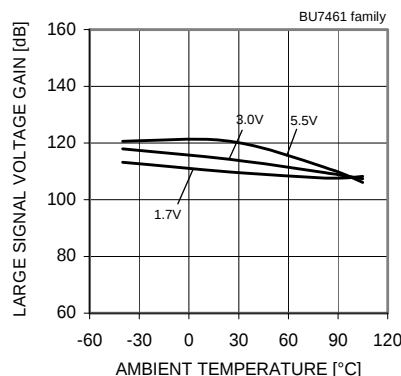


Fig.17
Power Supply Rejection Ratio
– Ambient Temperature

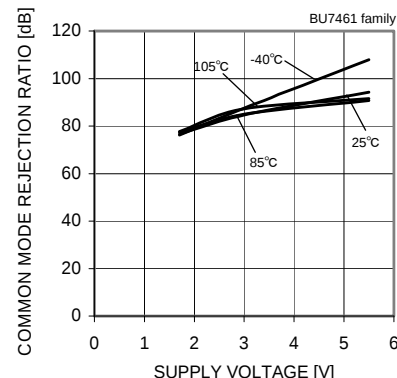


Fig.18
Common Mode Rejection Ratio
– Supply Voltage

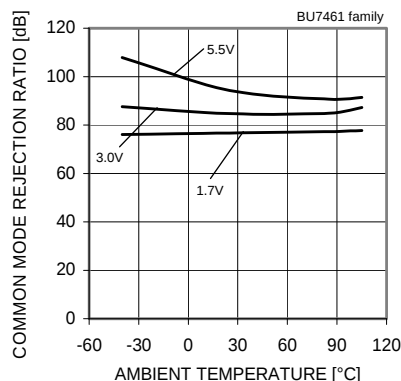


Fig.19
Common Mode Rejection Ratio
– Ambient Temperature

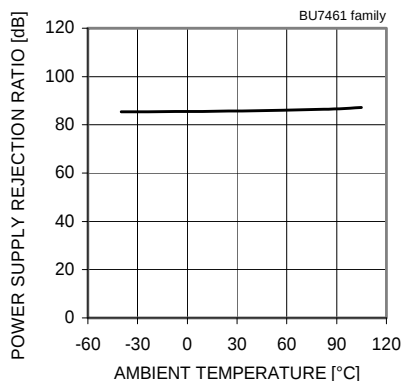


Fig.20
Large Signal Voltage Gain
– Ambient Temperature

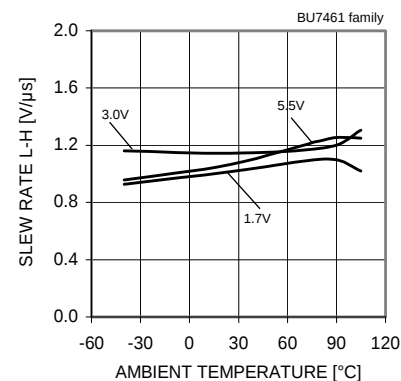


Fig.21
Slew Rate L-H – Ambient Temperature

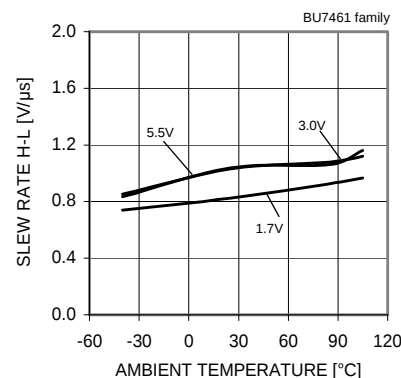


Fig.22
Slew Rate H-L – Ambient Temperature

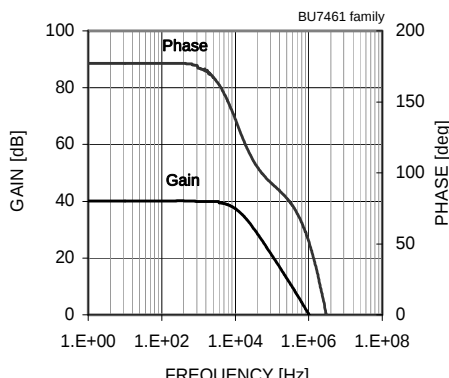


Fig.23
Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7461G: -40[°C] ~ +85[°C] BU7461SG: -40[°C] ~ +105[°C]

●Reference data (BU7462 family)

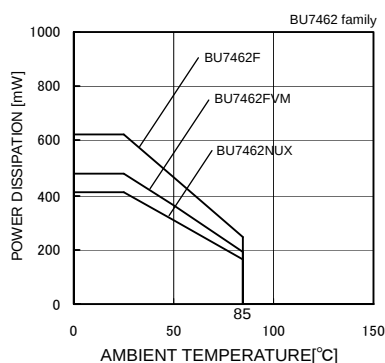


Fig.24
Derating curve

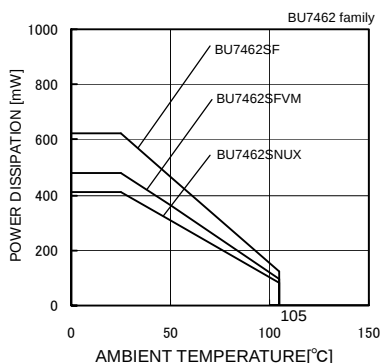


Fig.25
Derating curve

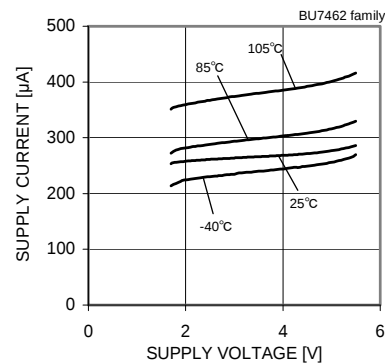


Fig.26
Supply Current – Supply Voltage

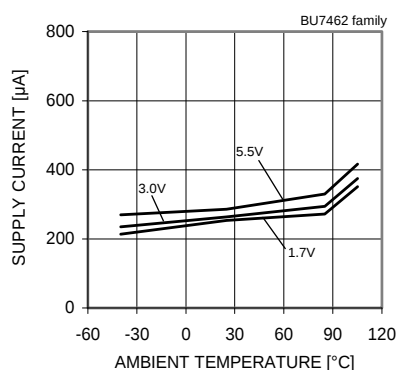


Fig.27
Supply Current – Ambient Temperature

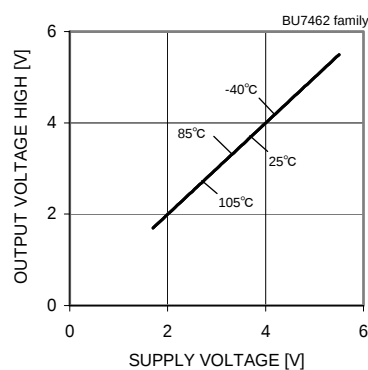


Fig.28
Output Voltage High – Supply Voltage
($R_L=10[k\Omega]$)

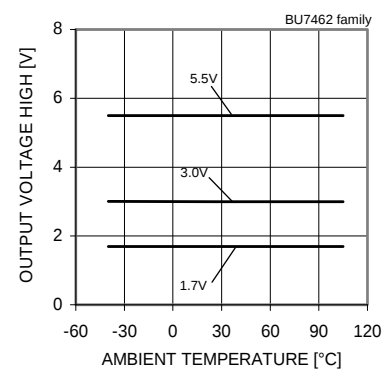


Fig.29
Output Voltage High – Ambient Temperature
($R_L=10[k\Omega]$)

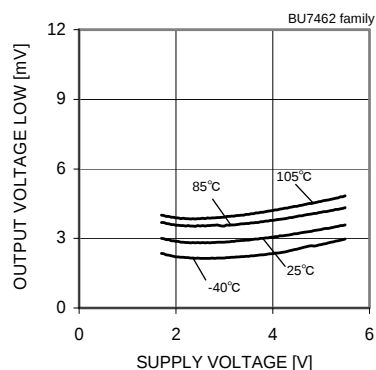


Fig.30
Output Voltage Low – Supply Voltage
($R_L=10[k\Omega]$)

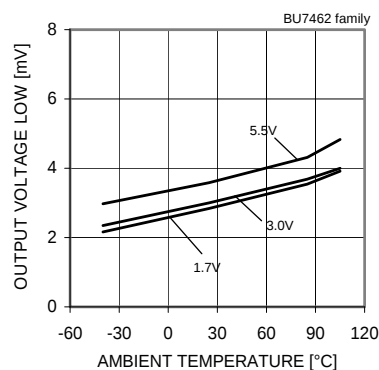


Fig.31
Output Voltage Low – Ambient Temperature
($R_L=10[k\Omega]$)

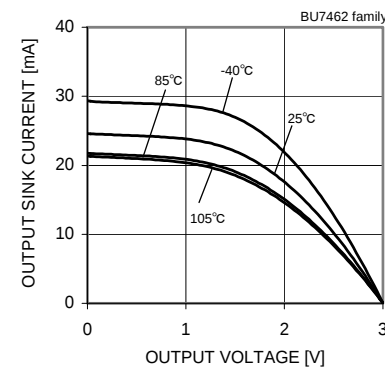


Fig.32
Output Source Current – Output Voltage
($V_{DD}=3.0[V]$)

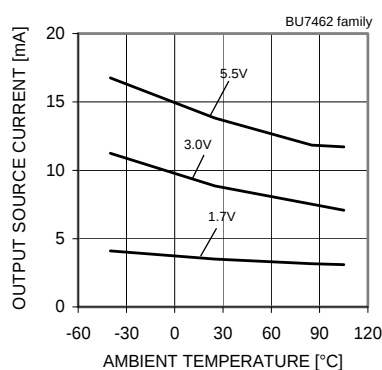


Fig.33
Output Source Current – Ambient Temperature
($V_{OUT}=V_{DD}-0.4[V]$)

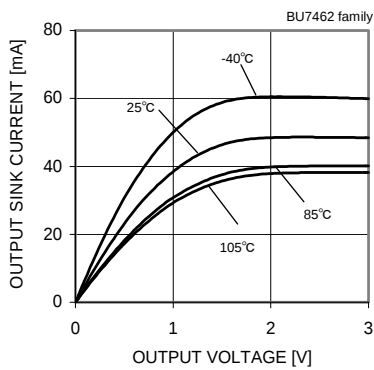


Fig.34
Output Sink Current – Output Voltage
($V_{DD}=3[V]$)

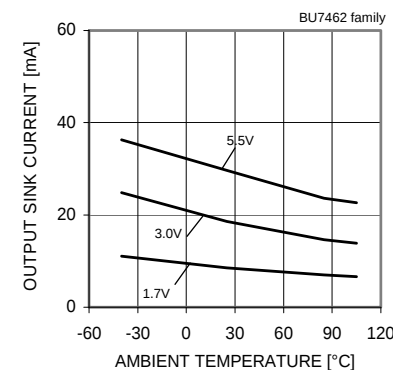


Fig.35
Output Sink Current – Ambient Temperature
($V_{OUT}=V_{SS}+0.4[V]$)

(*)The above data is ability value of sample, it is not guaranteed. BU7462F/FVM/NUX: -40[°C] ~ +85[°C] BU7462S F/FVM/NUX: -40[°C] ~ +105[°C]

●Reference data (BU7462 family)

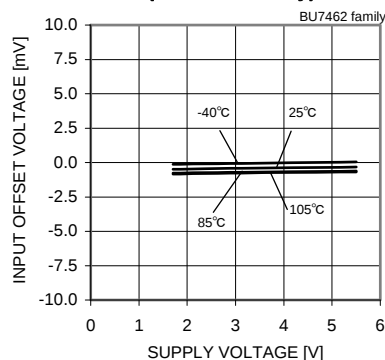


Fig.36

Input Offset Voltage – Supply Voltage
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

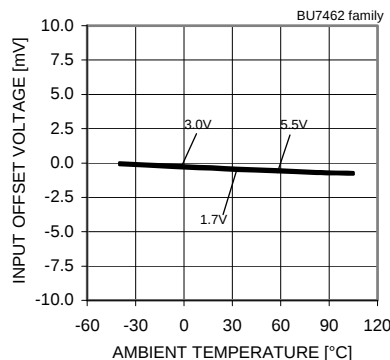


Fig.37

Input Offset Voltage – Ambient Temperature
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

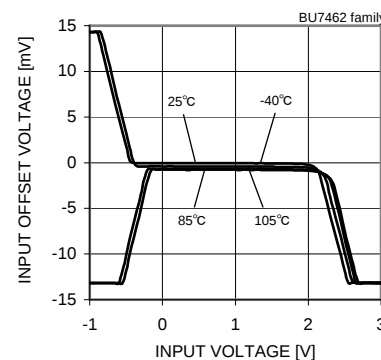


Fig.38

Input Offset Voltage – Input Voltage
($V_{DD} = 3[V]$)

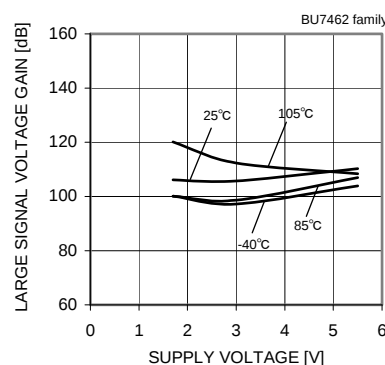


Fig.39

Large Signal Voltage Gain
– Supply Voltage

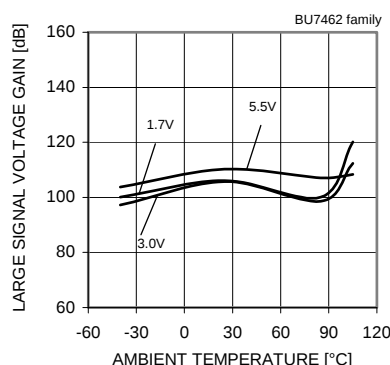


Fig.40

Large Signal Voltage Gain
– Ambient Temperature

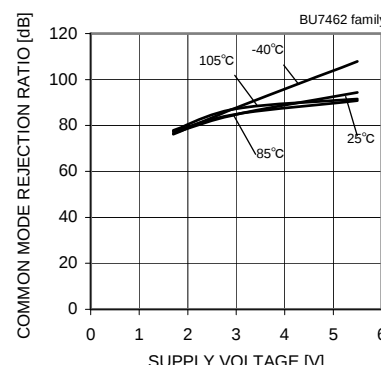


Fig.41

Common Mode Rejection Ratio
– Supply Voltage

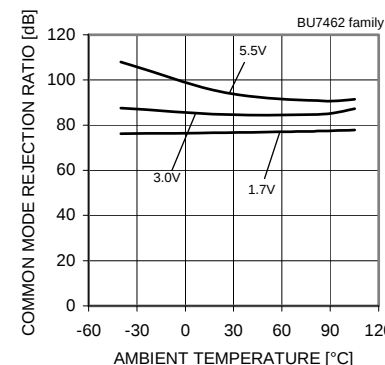


Fig.42

Common Mode Rejection Ratio
– Ambient Temperature

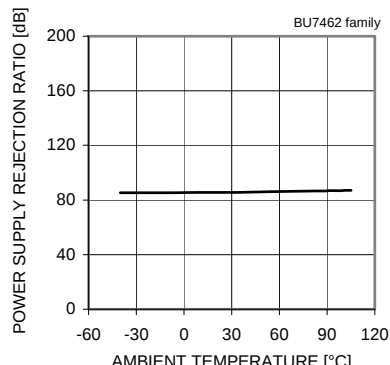


Fig.43

Power Supply Rejection Ratio
– Ambient Temperature

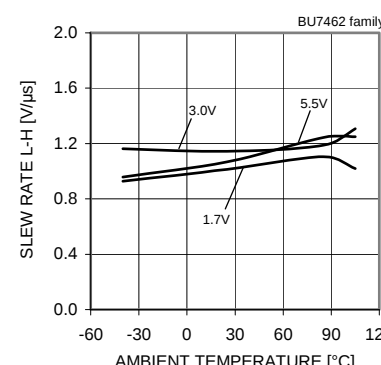


Fig.44

Slew Rate L-H – Ambient Temperature

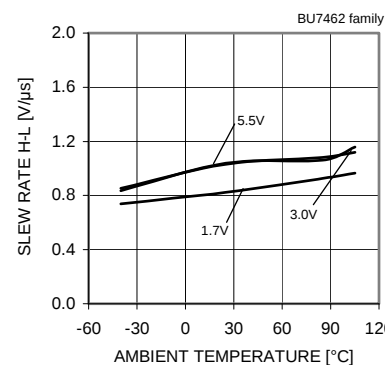


Fig.45

Slew Rate H-L – Ambient Temperature

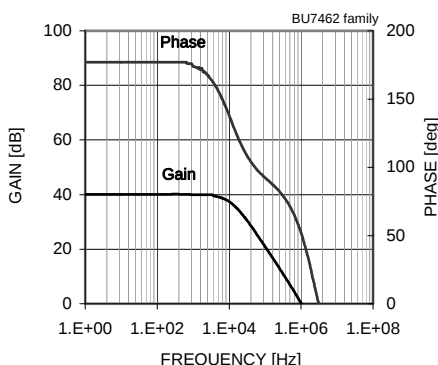


Fig.46

Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7462F/FVM/NUX: -40[°C] ~ +85[°C] BU7462S F/FVM/NUX: -40[°C] ~ +105[°C]

●Reference data (BU7464 family)

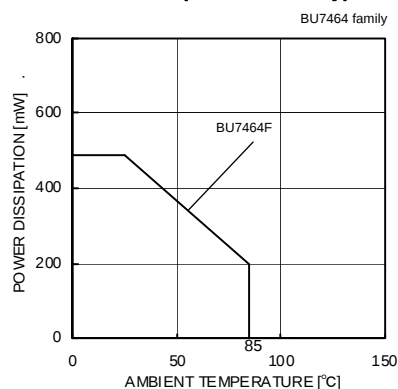


Fig.47
Derating curve

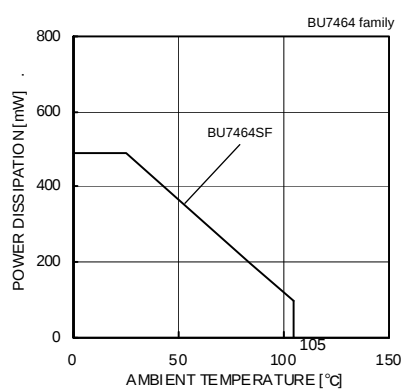


Fig.48
Derating curve

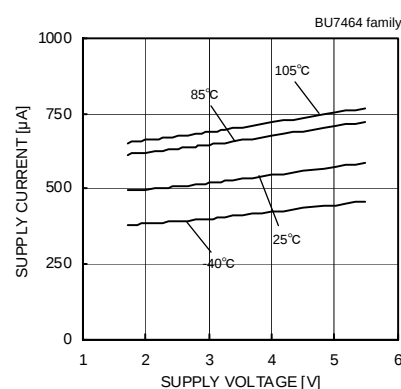


Fig.49
Supply Current – Supply Voltage

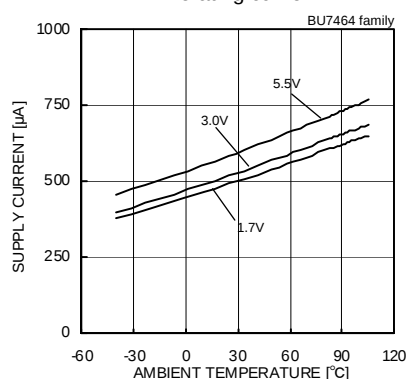


Fig.50
Supply Current – Ambient Temperature

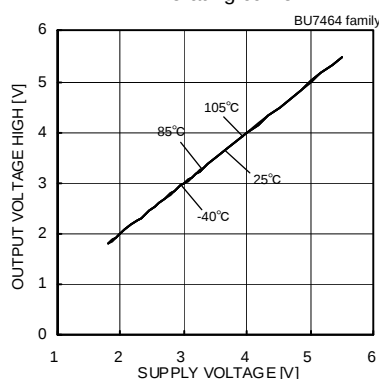


Fig.51
Output Voltage High – Supply Voltage
($R_L=10[k\Omega]$)

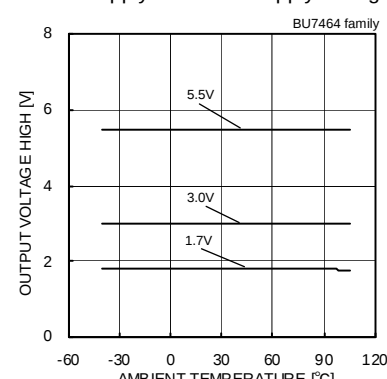


Fig.52
Output Voltage High – Ambient Temperature
($R_L=10[k\Omega]$)

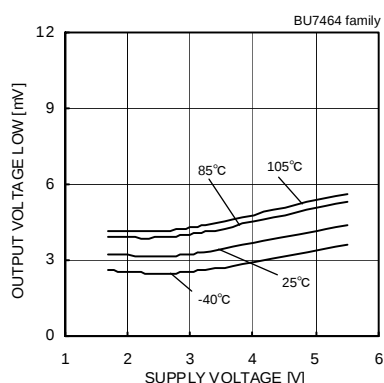


Fig.53
Output Voltage Low – Supply Voltage
($R_L=10[k\Omega]$)

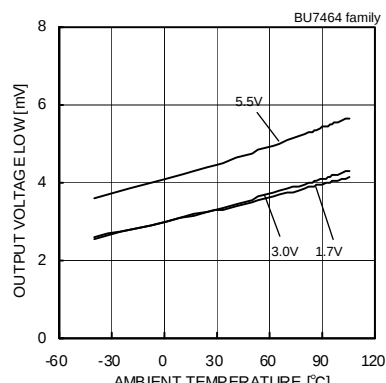


Fig.54
Output Voltage Low – Ambient Temperature
($R_L=10[k\Omega]$)

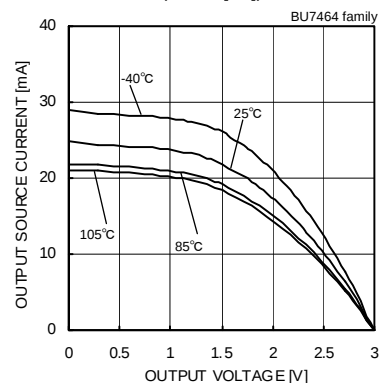


Fig.55
Output Source Current – Output Voltage
($V_{DD}=3.0[V]$)

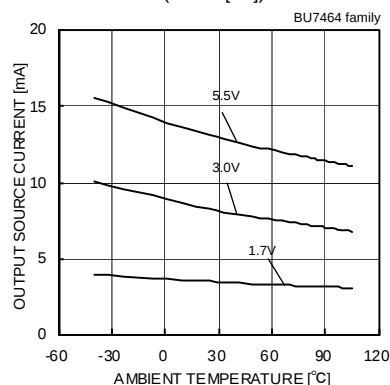


Fig.56
Output Source Current – Ambient Temperature
($V_{OUT}=V_{DD}-0.4[V]$)

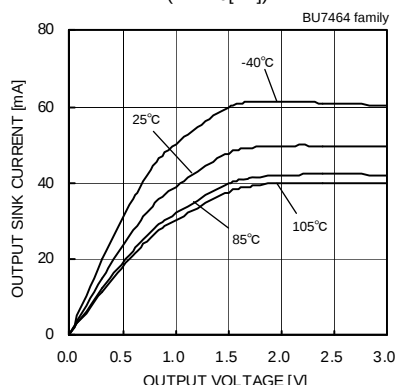


Fig.57
Output Sink Current – Output Voltage
($V_{DD}=3[V]$)

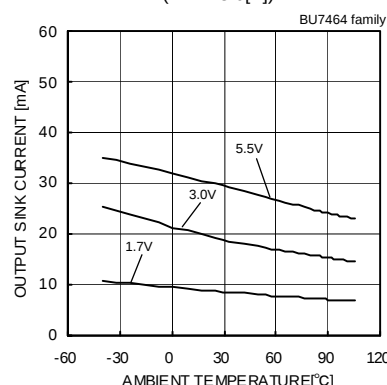


Fig.58
Output Sink Current – Ambient Temperature
($V_{OUT}=V_{SS}+0.4[V]$)

(*)The above data is ability value of sample, it is not guaranteed. BU7464F: -40[°C] ~ +85[°C] BU7464SF: -40[°C] ~ +105[°C]

●Reference data (BU7464 family)

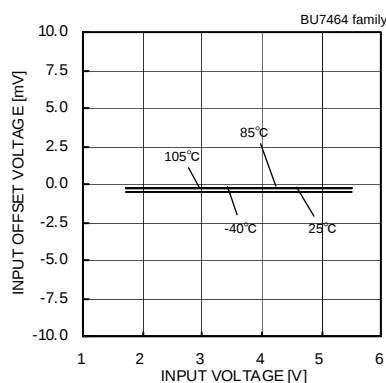


Fig.59

Input Offset Voltage – Supply Voltage
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

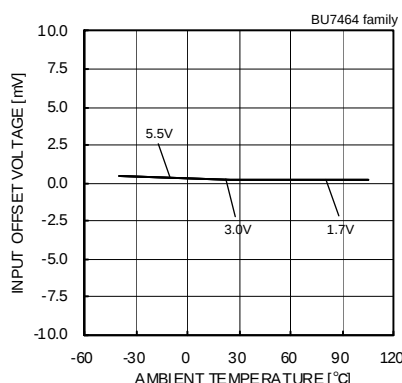


Fig.60

Input Offset Voltage – Ambient Temperature
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

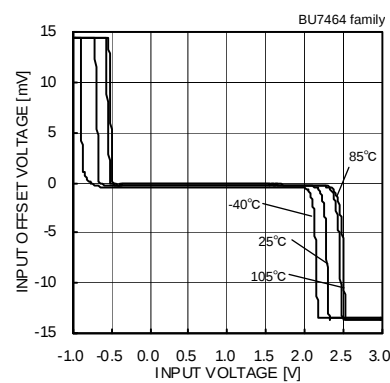


Fig.61

Input Offset Voltage – Input Voltage
($V_{DD} = 3[V]$)

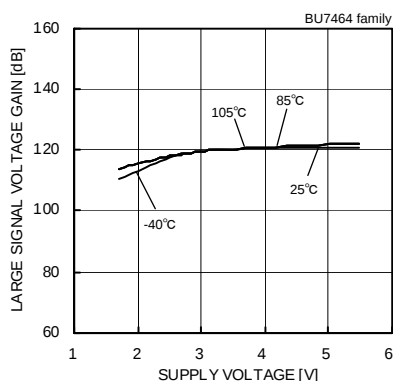


Fig.62

Large Signal Voltage Gain
– Supply Voltage

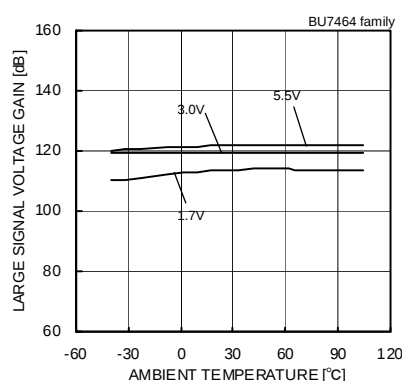


Fig.63

Large Signal Voltage Gain
– Ambient Temperature

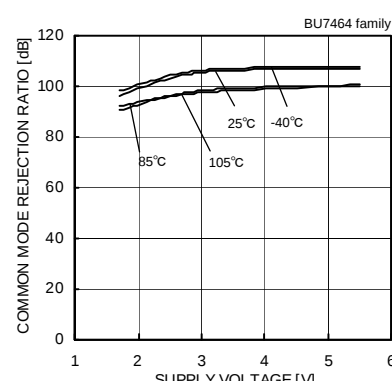


Fig.64

Common Mode Rejection Ratio
– Supply Voltage

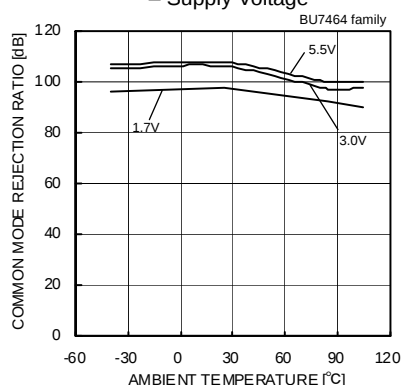


Fig.65

Common Mode Rejection Ratio
– Ambient Temperature

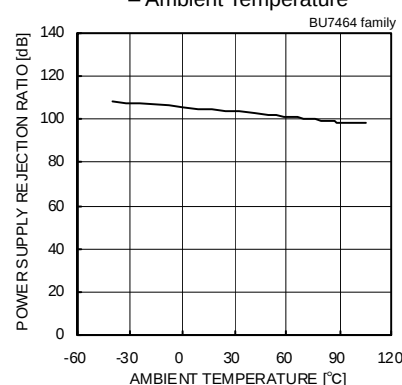


Fig.66

Power Supply Rejection Ratio
– Ambient Temperature

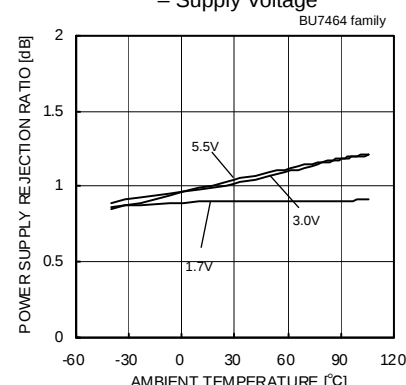


Fig.67

Slew Rate L-H – Ambient Temperature

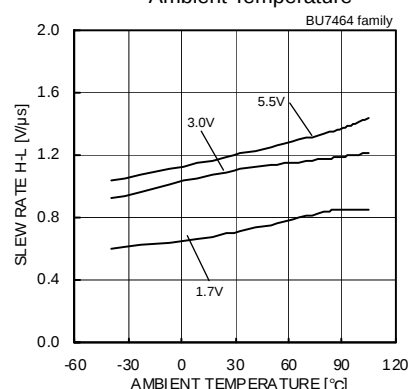


Fig.68

Slew Rate H-L – Ambient Temperature

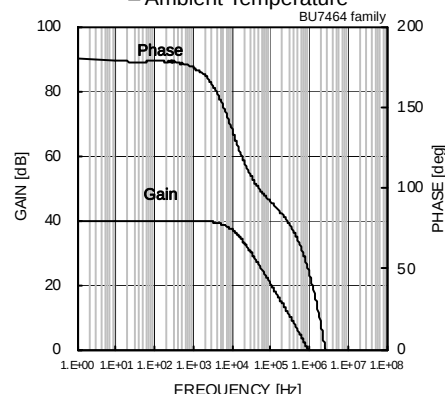


Fig.69

Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7464F: -40[°C] ~ +85[°C] BU7464SF: -40[°C] ~ +105[°C]

●Reference data (BU7465 family)

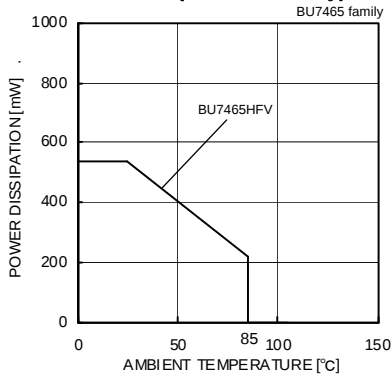


Fig.70

Derating curve

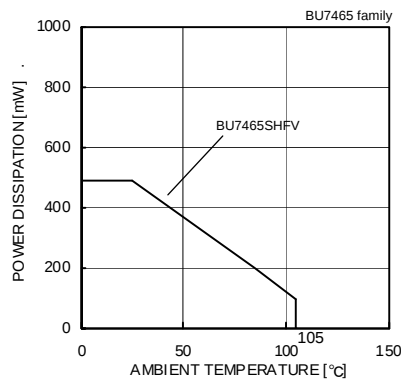


Fig.71

Derating curve

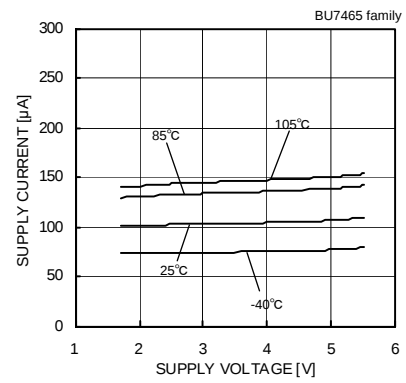


Fig.72

Supply Current – Supply Voltage

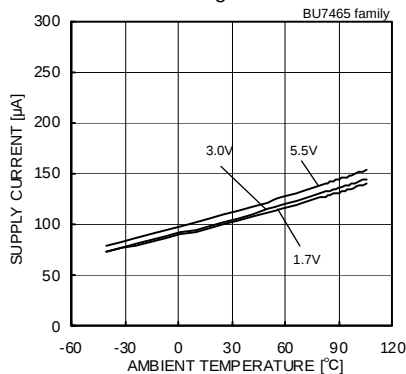


Fig.73

Supply Current – Ambient Temperature

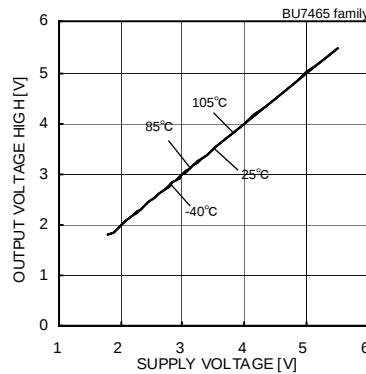


Fig.74

Output Voltage High – Supply Voltage
($R_L=10[k\Omega]$)

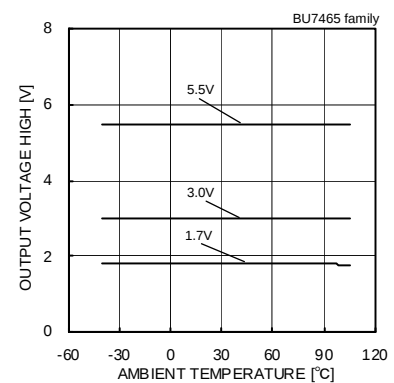


Fig.75

Output Voltage High – Ambient Temperature
($R_L=10[k\Omega]$)

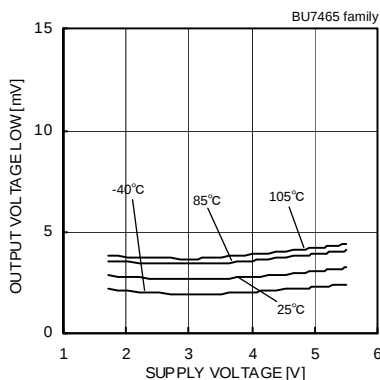


Fig.76

Output Voltage Low – Supply Voltage
($R_L=10[k\Omega]$)

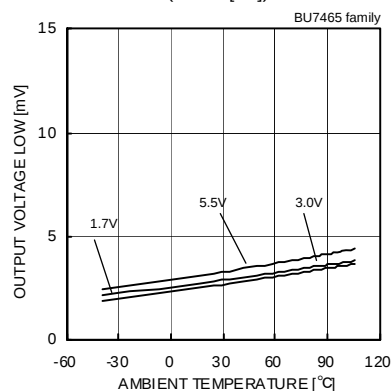


Fig.77

Output Voltage Low – Ambient Temperature
($R_L=10[k\Omega]$)

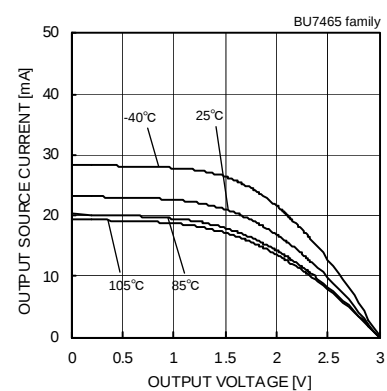


Fig.78

Output Source Current – Output Voltage
($V_{DD}=3[V]$)

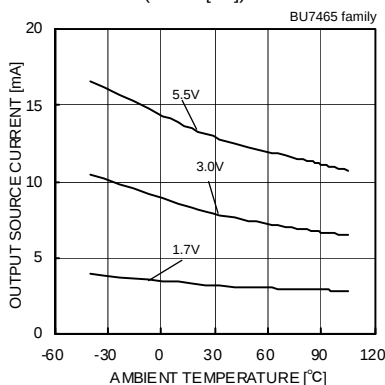


Fig.79

Output Source Current – Ambient Temperature
($V_{OUT}=V_{DD}-0.4[V]$)

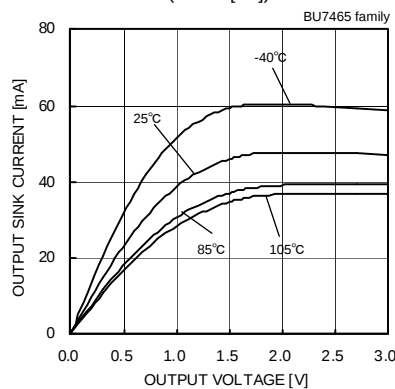


Fig.80

Output Sink Current – Output Voltage
($V_{DD}=3[V]$)

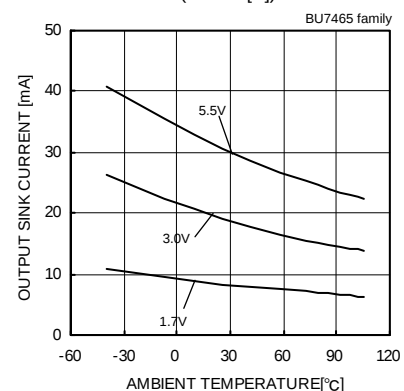


Fig.81

Output Sink Current – Ambient Temperature
($V_{OUT}=V_{SS}+0.4[V]$)

(*)The above data is ability value of sample, it is not guaranteed. BU7465HfV: $-40[^\circ\text{C}] \sim +85[^\circ\text{C}]$ BU7465SHfV: $-40[^\circ\text{C}] \sim +105[^\circ\text{C}]$

●Reference data (BU7465 family)

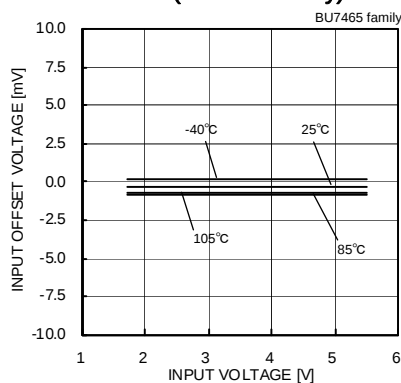


Fig.82

Input Offset Voltage – Supply Voltage
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

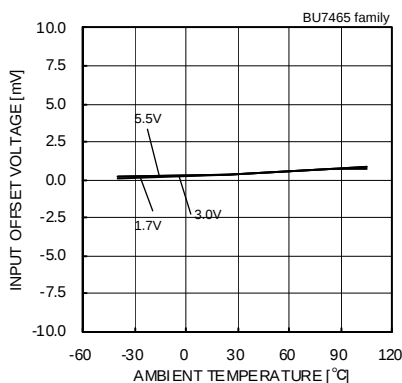


Fig.83

Input Offset Voltage – Ambient Temperature
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

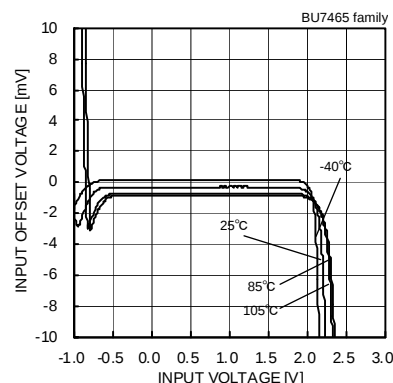


Fig.84

Input Offset Voltage – Input Voltage
($V_{DD} = 3[V]$)

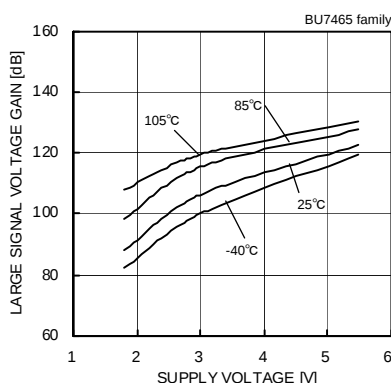


Fig.85

Large Signal Voltage Gain
– Supply Voltage

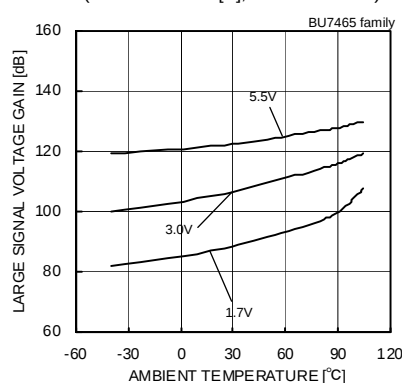


Fig.86

Large Signal Voltage Gain
– Ambient Temperature

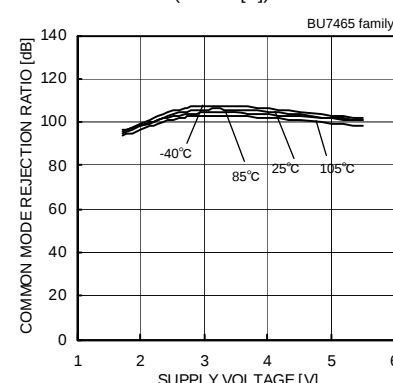


Fig.87

Common Mode Rejection Ratio
– Supply Voltage

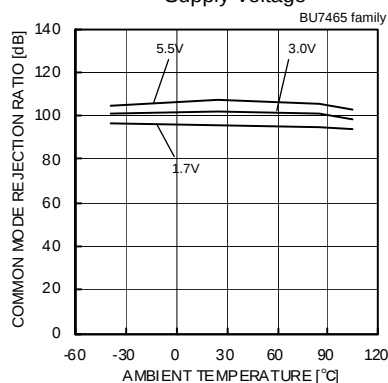


Fig.88

Common Mode Rejection Ratio
– Ambient Temperature

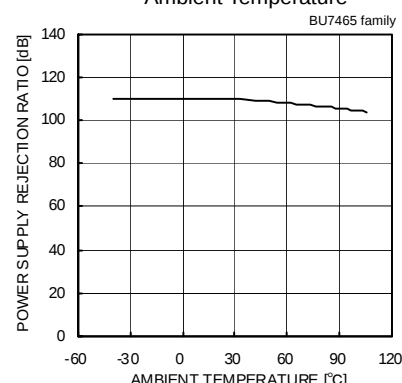


Fig.89

Power Supply Rejection Ratio
– Ambient Temperature

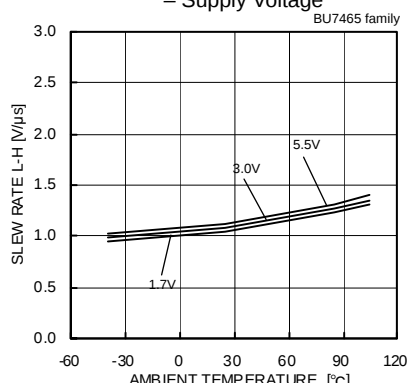


Fig.90

Slew Rate L-H – Ambient Temperature

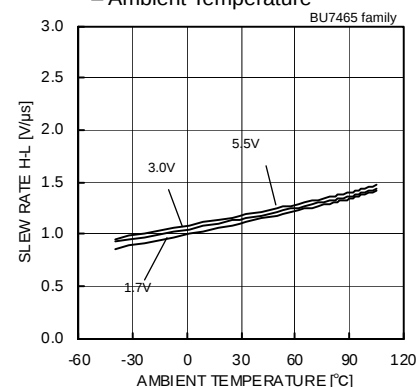


Fig.91

Slew Rate H-L – Ambient Temperature

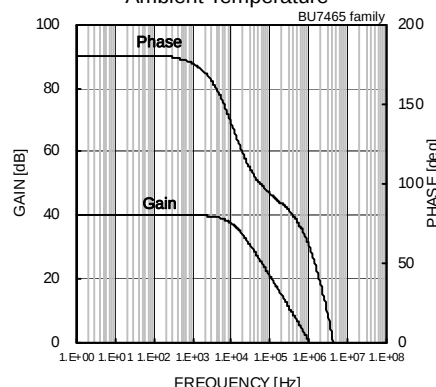


Fig.92

Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7465HFV: -40[°C] ~ +85[°C] BU7465SHFV: -40[°C] ~ +105[°C]

●Reference data (BU7441 family)

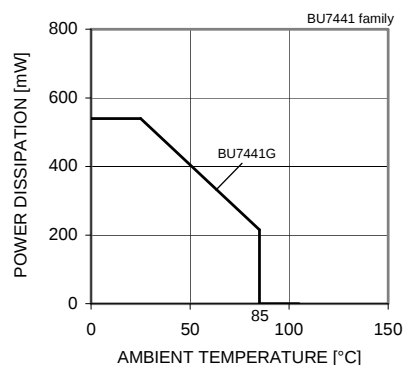


Fig.93
Derating curve

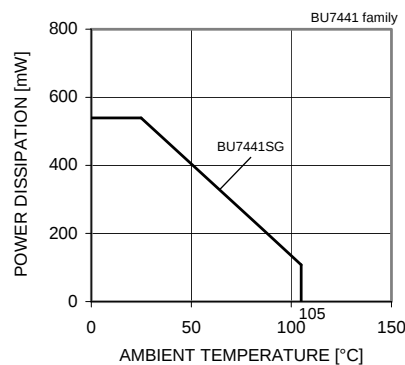


Fig.94
Derating curve

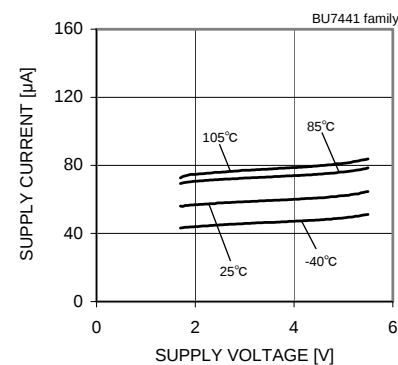


Fig.95
Supply Current – Supply Voltage

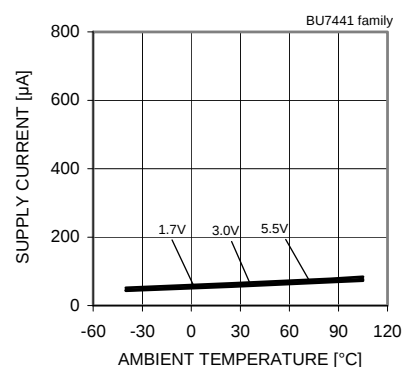


Fig.96
Supply Current – Ambient Temperature

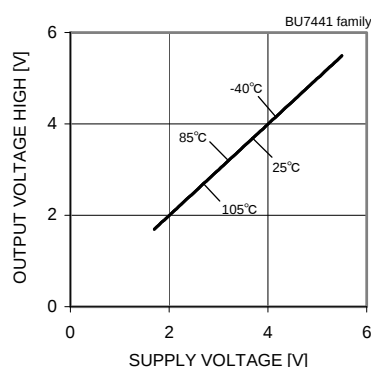


Fig.97
Output Voltage High – Supply Voltage
($R_L=10[k\Omega]$)

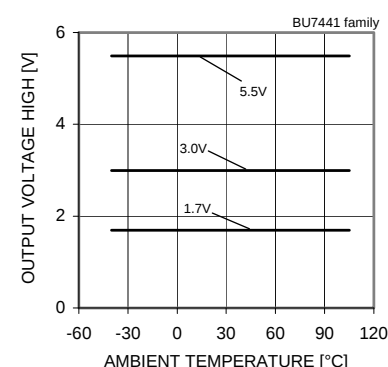


Fig.98
Output Voltage High – Ambient Temperature
($R_L=10[k\Omega]$)

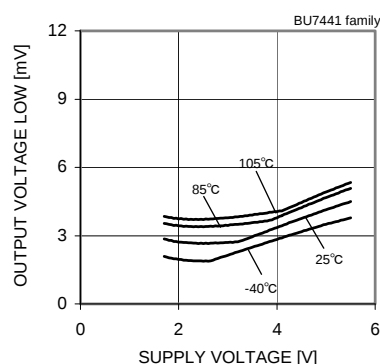


Fig.99
Output Voltage Low – Supply Voltage
($R_L=10[k\Omega]$)

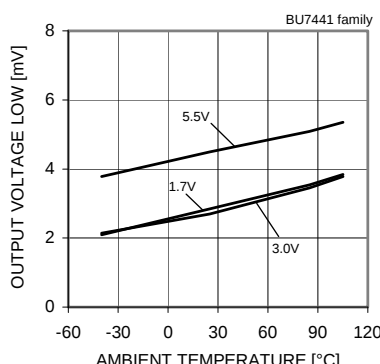


Fig.100
Output Voltage Low – Ambient Temperature
($R_L=10[k\Omega]$)

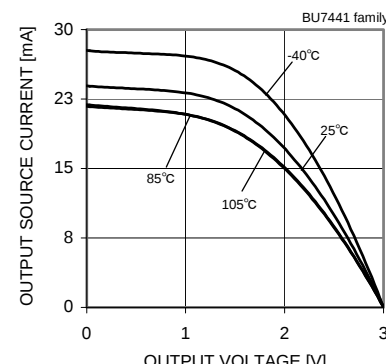


Fig.101
Output Source Current – Output Voltage
($V_{DD}=3[V]$)

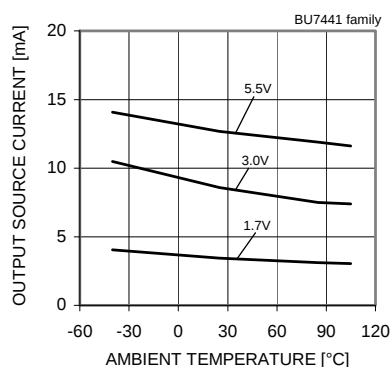


Fig.102
Output Source Current – Ambient Temperature
($V_{OUT}=V_{DD}-0.4[V]$)

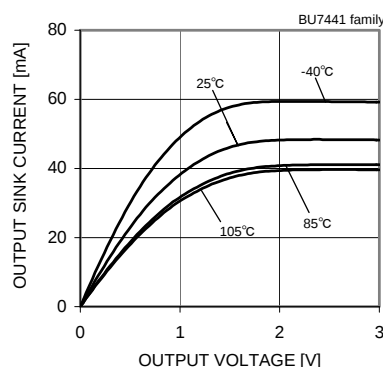


Fig.103
Output Sink Current – Output Voltage
($V_{DD}=3[V]$)

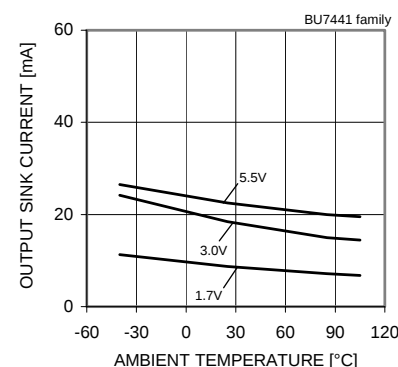


Fig.104
Output Sink Current – Ambient Temperature
($V_{OUT}=V_{SS}+0.4[V]$)

(*)The above data is ability value of sample, it is not guaranteed. BU7441G: -40[°C] ~ +85[°C] BU7441SG: -40[°C] ~ +105[°C]

●Reference data (BU7441 family)

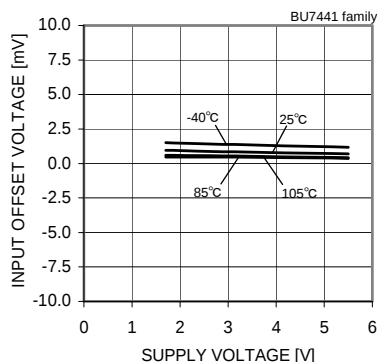


Fig.105

Input Offset Voltage – Supply Voltage
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

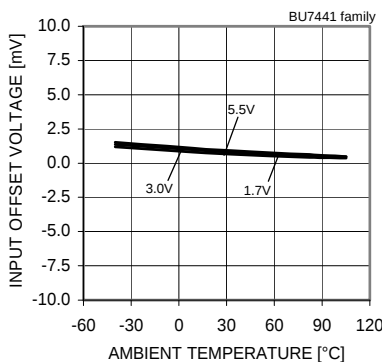


Fig.106

Input Offset Voltage – Ambient Temperature
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

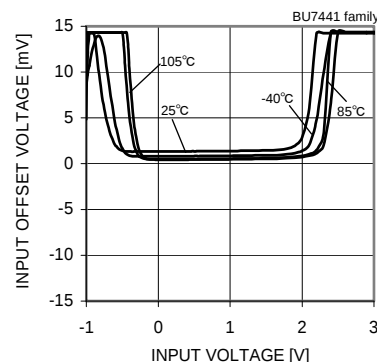


Fig.107

Input Offset Voltage – Input Voltage
($V_{DD} = 3[V]$)

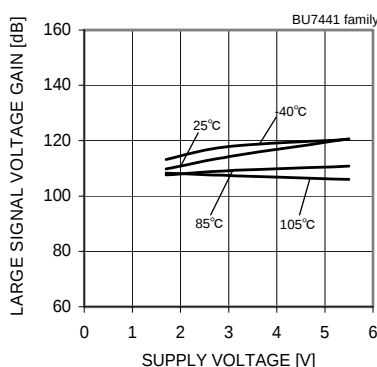


Fig.108

Large Signal Voltage Gain
– Supply Voltage

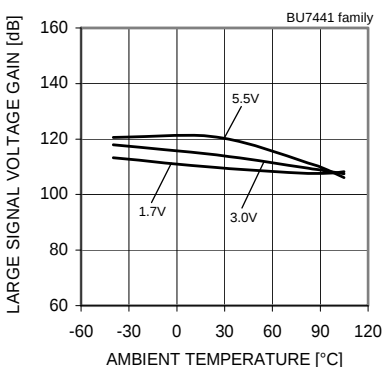


Fig.109

Large Signal Voltage Gain
– Ambient Temperature

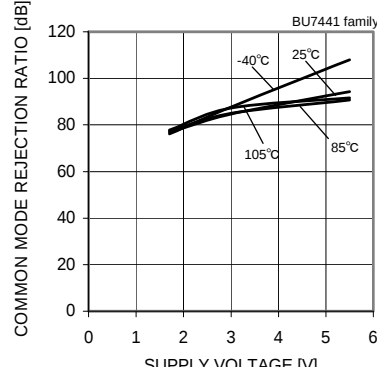


Fig.110

Common Mode Rejection Ratio
– Supply Voltage

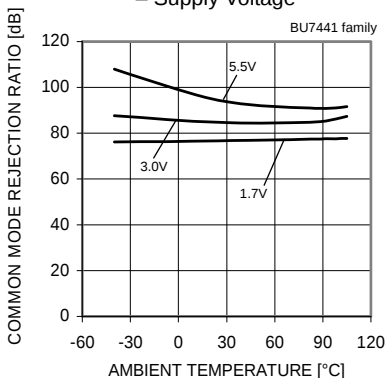


Fig.111

Common Mode Rejection Ratio
– Ambient Temperature

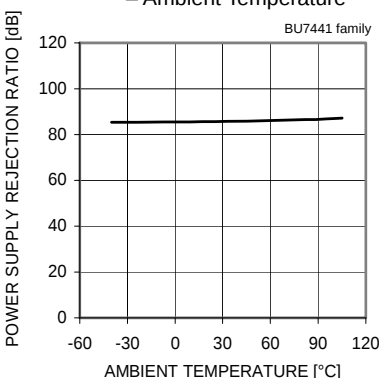


Fig.112

Power Supply Rejection Ratio
– Ambient Temperature

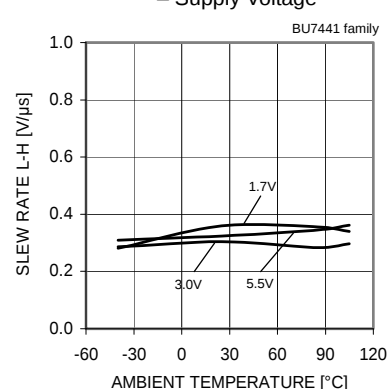


Fig.113

Slew Rate L-H – Ambient Temperature

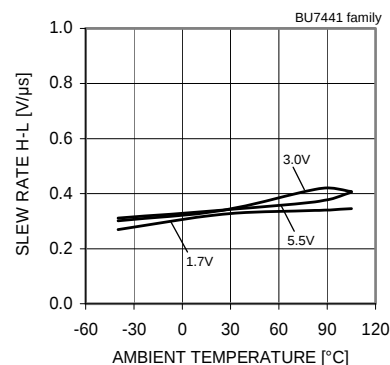


Fig.114

Slew Rate H-L – Ambient Temperature

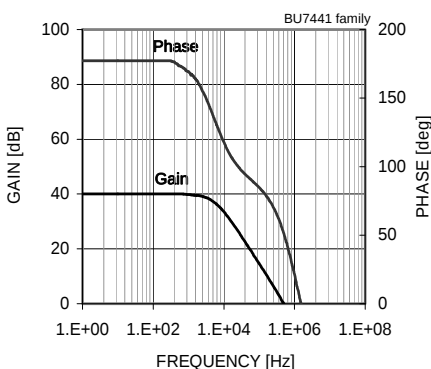


Fig.115

Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7441G: -40[°C] ~ +85[°C] BU7441SG: -40[°C] ~ +105[°C]

●Reference data (BU7442 family)

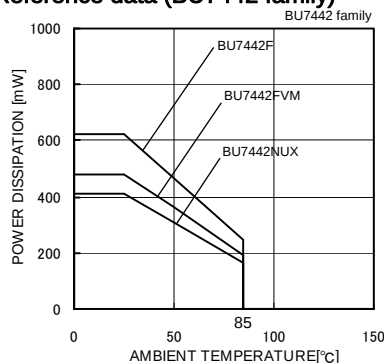


Fig.116

Derating curve

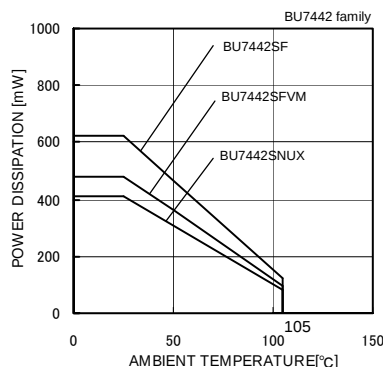


Fig.117

Derating curve

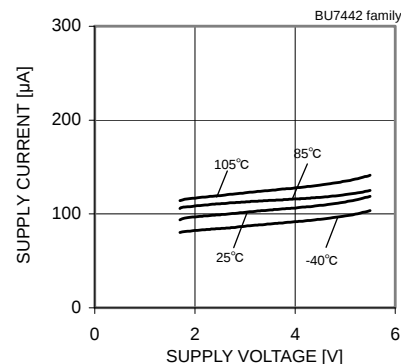


Fig.118

Supply Current – Supply Voltage

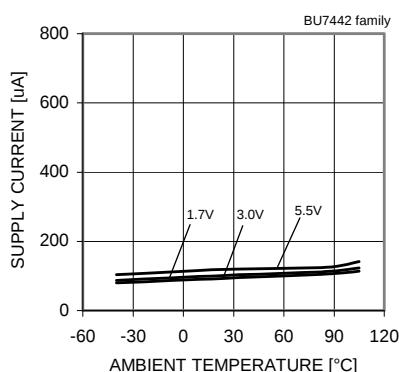


Fig.119

Supply Current – Ambient Temperature

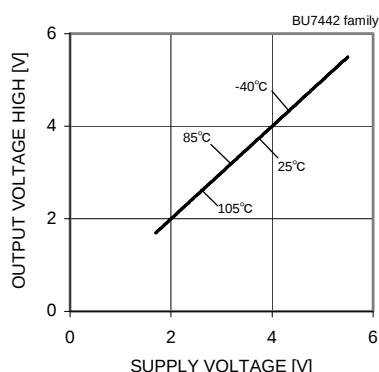


Fig.120

Output Voltage High – Supply Voltage
($R_L=10[k\Omega]$)

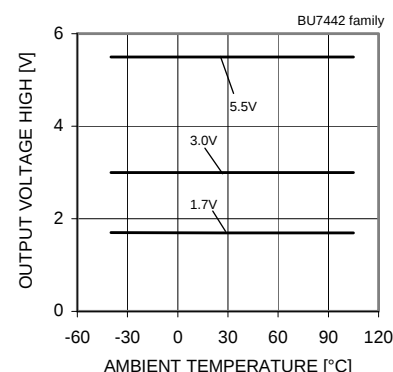


Fig.121

Output Voltage High – Ambient Temperature
($R_L=10[k\Omega]$)

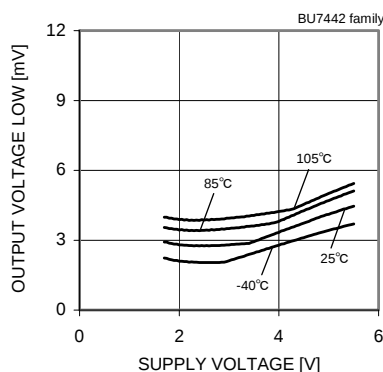


Fig.122

Output Voltage Low – Supply Voltage
($R_L=10[k\Omega]$)

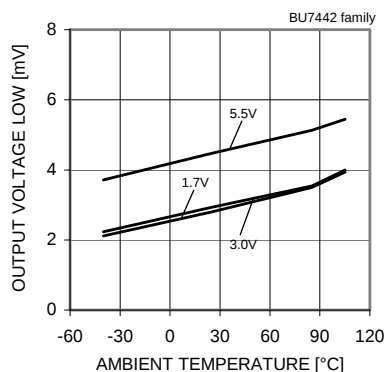


Fig.123

Output Voltage Low – Ambient Temperature
($R_L=10[k\Omega]$)

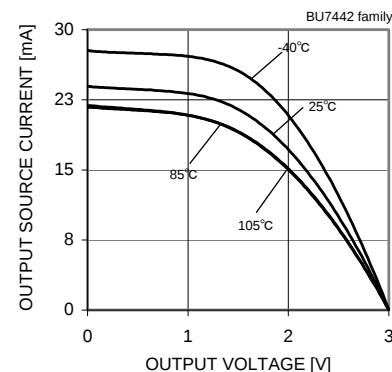


Fig.124

Output Source Current – Output Voltage
($V_{DD}=3.0[V]$)

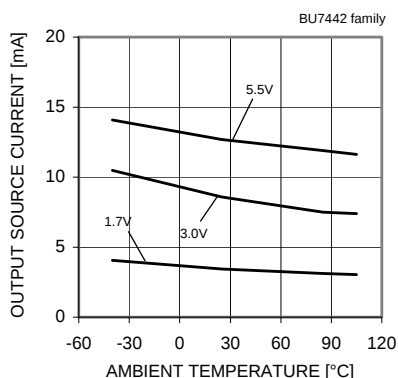


Fig.125

Output Source Current – Ambient Temperature
($V_{OUT}=V_{DD}-0.4[V]$)

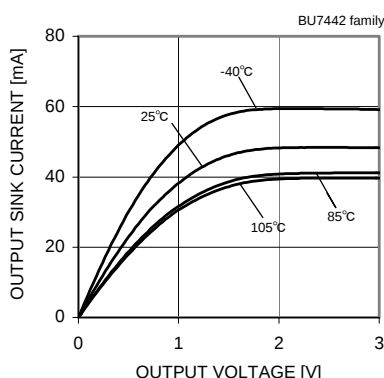


Fig.126

Output Sink Current – Output Voltage
($V_{DD}=3[V]$)

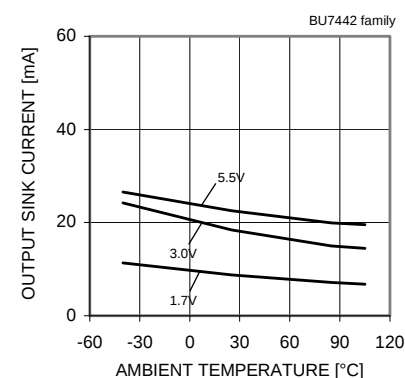


Fig.127

Output Sink Current – Ambient Temperature
($V_{OUT}=V_{SS}+0.4[V]$)

(*)The above data is ability value of sample, it is not guaranteed. BU7442F/FVM/NUX: -40[°C] ~ +85[°C]

BU7442S F/FVM/NUX: -40[°C] ~ +105[°C]

●Reference data (BU7442 family)

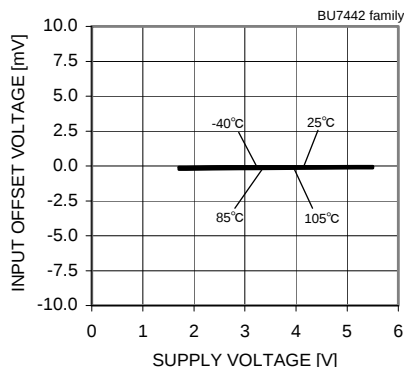


Fig.128
Input Offset Voltage – Supply Voltage
(Vicm= VDD-1.2[V], VOUT= VDD/2)

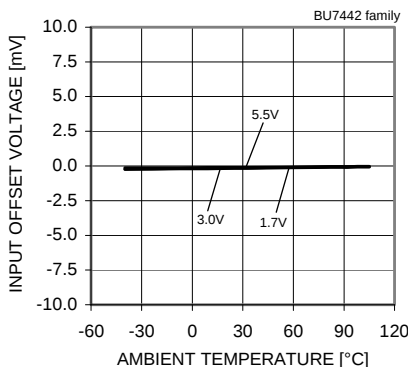


Fig.129
Input Offset Voltage – Ambient Temperature
(Vicm= VDD-1.2[V], VOUT= VDD/2)

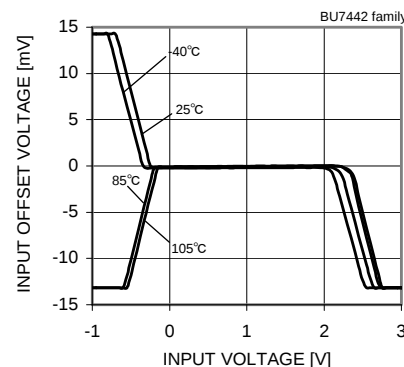


Fig.130
Input Offset Voltage – Input Voltage
(VDD=3[V])

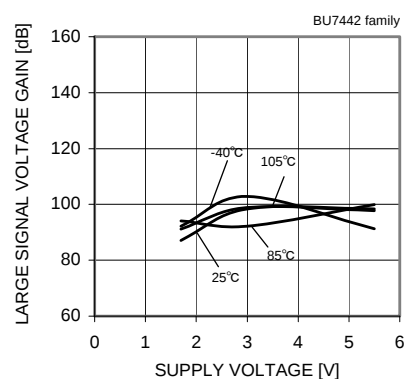


Fig.131
Large Signal Voltage Gain
– Supply Voltage

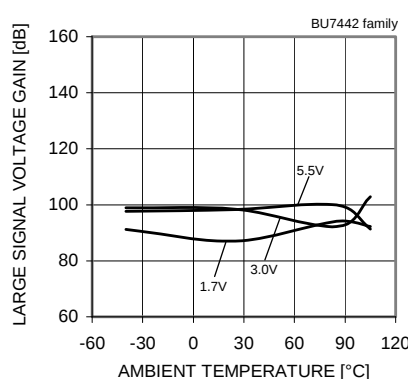


Fig.132
Large Signal Voltage Gain
– Ambient Temperature

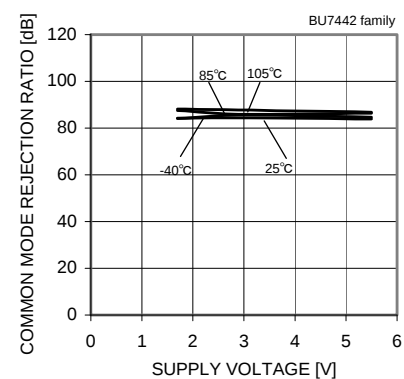


Fig.133
Common Mode Rejection Ratio
– Supply Voltage

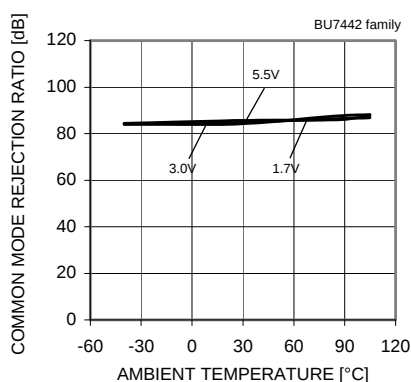


Fig.134
Common Mode Rejection Ratio
– Ambient Temperature

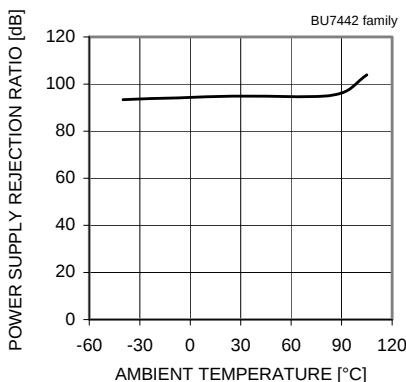


Fig.135
Power Supply Rejection Ratio
– Ambient Temperature

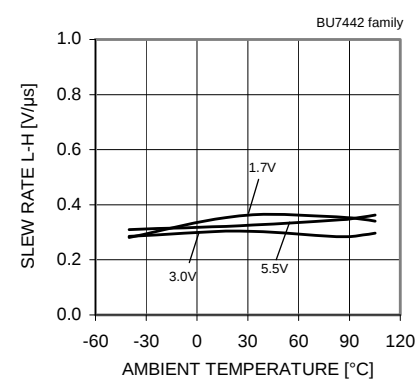


Fig.136
Slew Rate L-H – Ambient Temperature

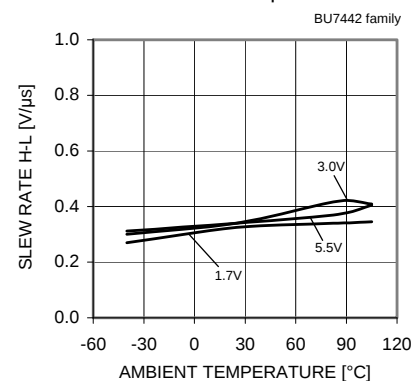


Fig.137
Slew Rate H-L – Ambient Temperature

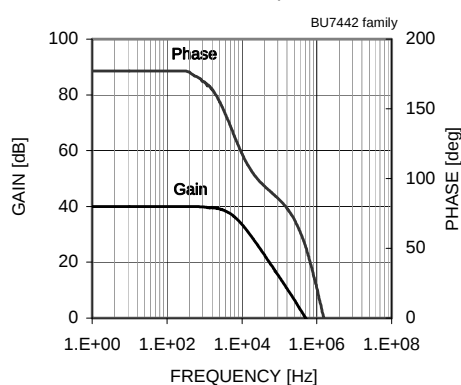


Fig.138
Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7442F/FVM/NUX: -40[°C] ~ +85[°C] BU7442S F/FVM/NUX: -40[°C] ~ +105[°C]

●Reference data (BU7444 family)

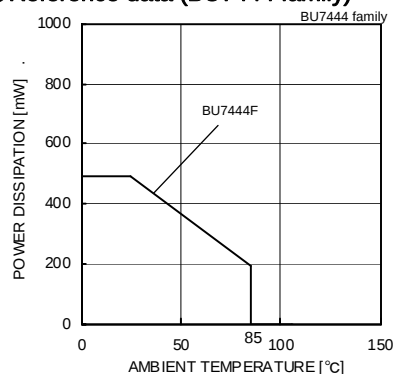


Fig.139
Derating curve

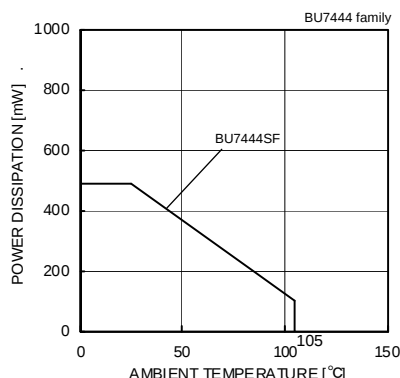


Fig.140
Derating curve

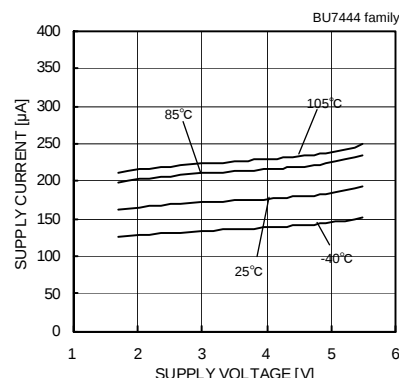


Fig.141
Supply Current – Supply Voltage

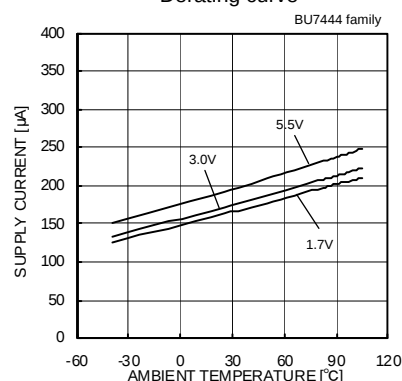


Fig.142
Supply Current – Ambient Temperature

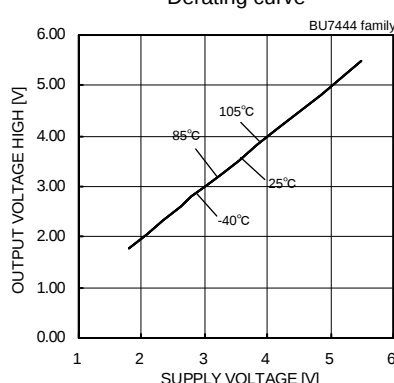


Fig.143
Output Voltage High – Supply Voltage
(RL=10[kΩ])

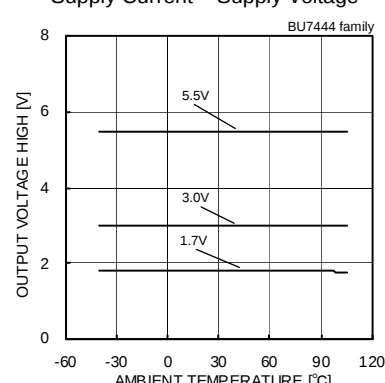


Fig.144
Output Voltage High – Ambient Temperature
(RL=10[kΩ])

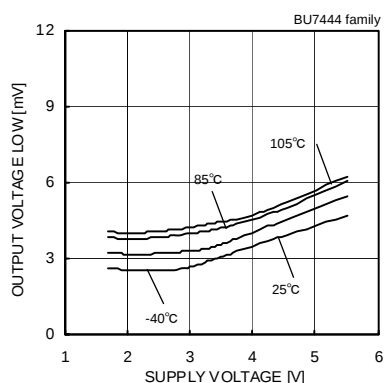


Fig.145
Output Voltage Low – Supply Voltage
(RL=10[kΩ])

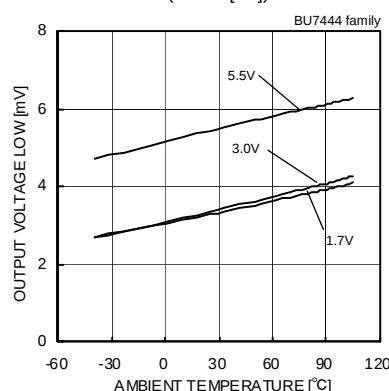


Fig.146
Output Voltage Low – Ambient Temperature
(RL=10[kΩ])

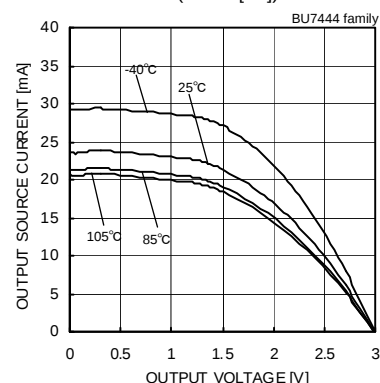


Fig.147
Output Source Current – Output Voltage
(VDD=3.0[V])

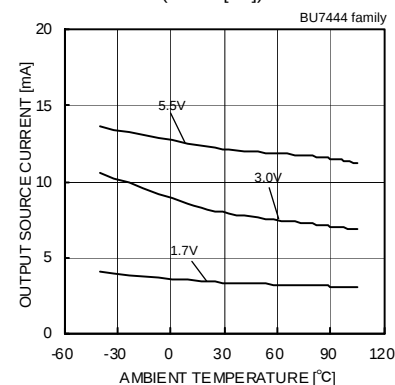


Fig.148
Output Source Current – Ambient Temperature
(VOUT=VDD-0.4[V])

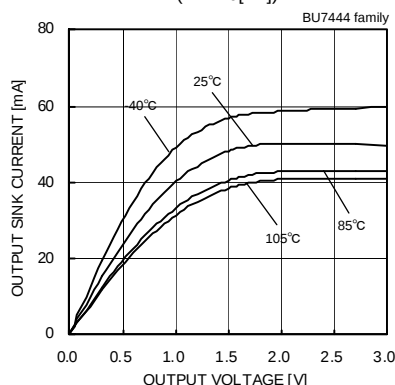


Fig.149
Output Sink Current – Output Voltage
(VDD=3[V])

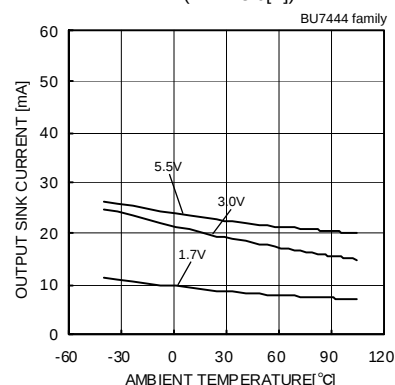


Fig.150
Output Sink Current – Ambient Temperature
(VOUT=VSS+0.4[V])

(*)The above data is ability value of sample, it is not guaranteed. BU7444F/FVM/NUX: -40[°C] ~ +85[°C] BU7444S F/FVM/NUX: -40[°C] ~ +105[°C]

●Reference data (BU7444 family)

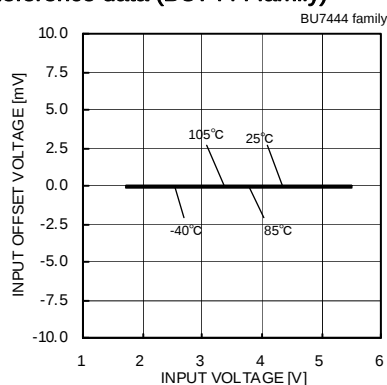


Fig.151
Input Offset Voltage – Supply Voltage
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

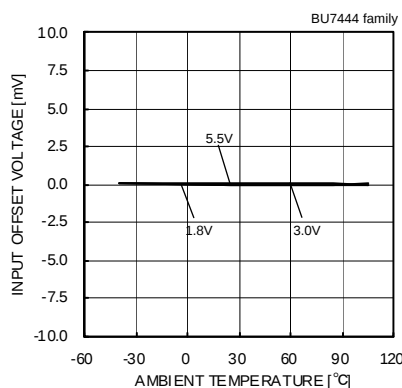


Fig.152
Input Offset Voltage – Ambient Temperature
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

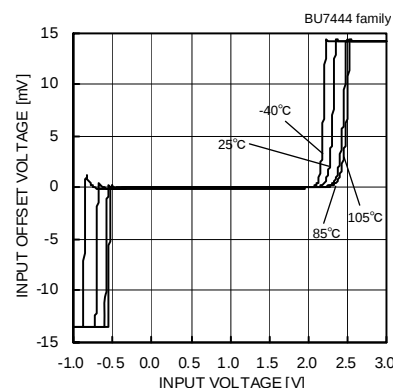


Fig.153
Input Offset Voltage – Input Voltage
($V_{DD} = 3[V]$)

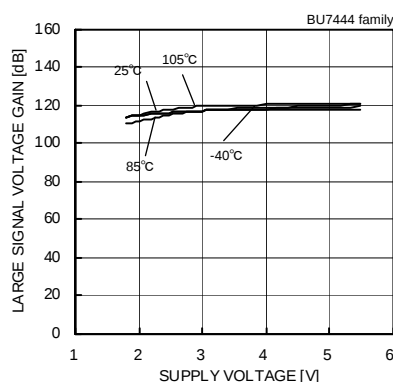


Fig.154
Large Signal Voltage Gain
– Supply Voltage

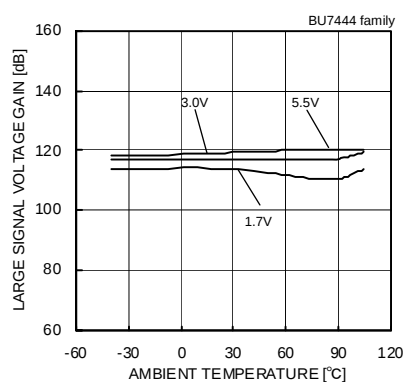


Fig.155
Large Signal Voltage Gain
– Ambient Temperature

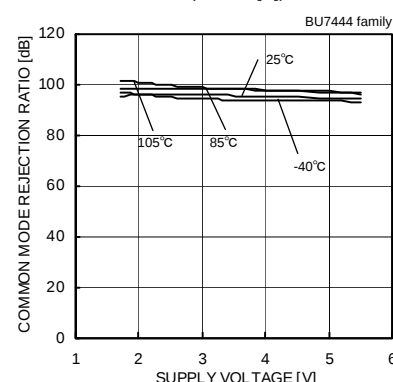


Fig.156
Common Mode Rejection Ratio
– Supply Voltage

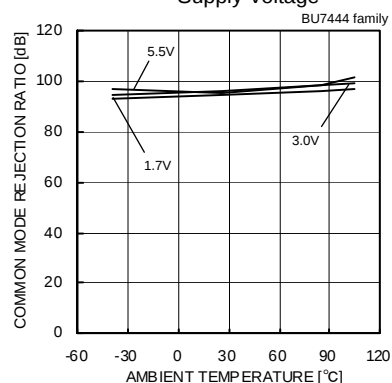


Fig.157
Common Mode Rejection Ratio
– Ambient Temperature

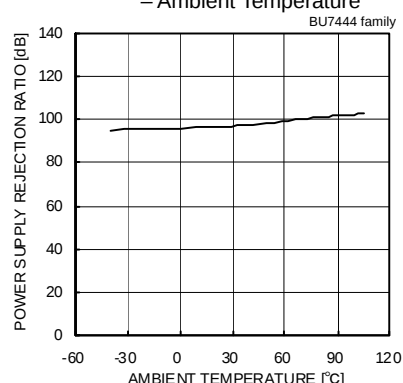


Fig.158
Power Supply Rejection Ratio
– Ambient Temperature

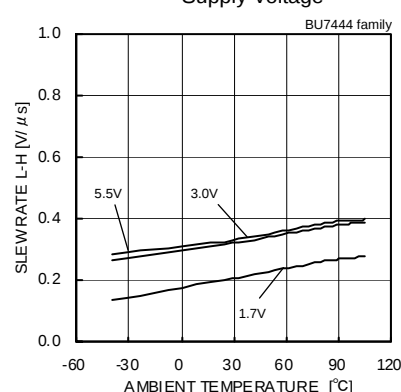


Fig.159
Slew Rate L-H – Ambient Temperature

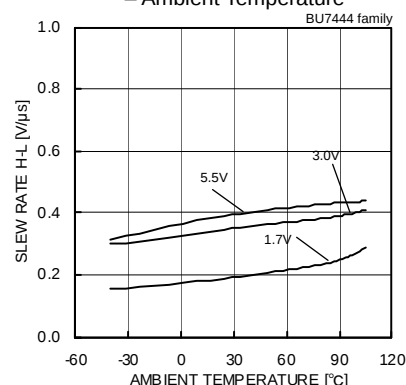


Fig.160
Slew Rate H-L – Ambient Temperature

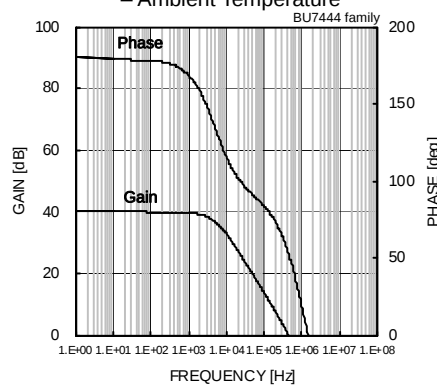


Fig.161
Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7444F/FVM/NUX: -40[°C] ~ +85[°C] BU7444S F/FVM/NUX: -40[°C] ~ +105[°C]

●Reference data (BU7445 family)

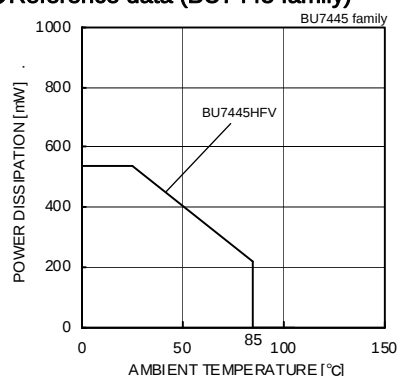


Fig.162
Derating curve

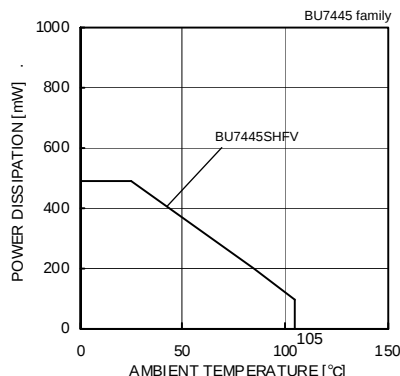


Fig.163
Derating curve

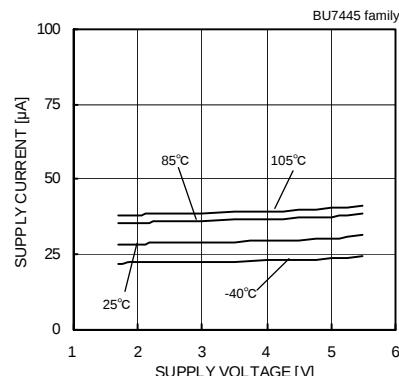


Fig.164
Supply Current – Supply Voltage

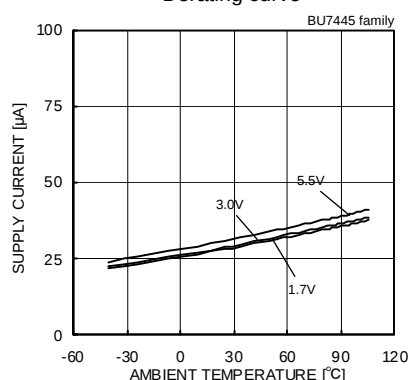


Fig.165
Supply Current – Ambient Temperature

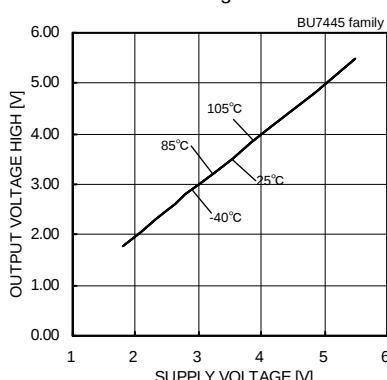


Fig.166
Output Voltage High – Supply Voltage
($R_L=10[k\Omega]$)

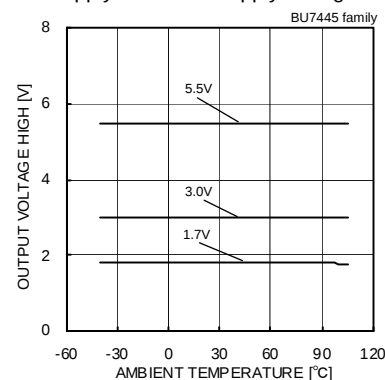


Fig.167
Output Voltage High – Ambient Temperature
($R_L=10[k\Omega]$)

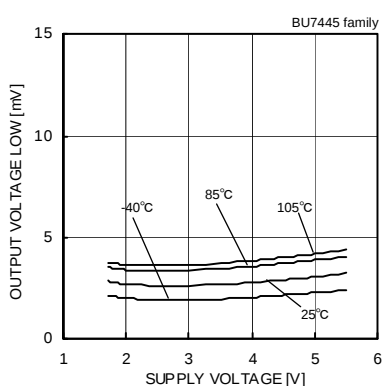


Fig.168
Output Voltage Low – Supply Voltage
($R_L=10[k\Omega]$)

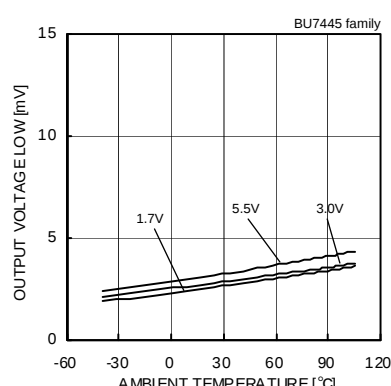


Fig.169
Output Voltage Low – Ambient Temperature
($R_L=10[k\Omega]$)

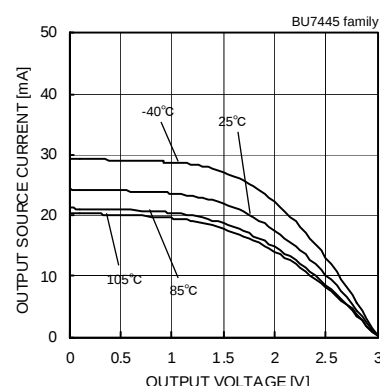


Fig.170
Output Source Current – Output Voltage
($V_{DD}=3.0[V]$)

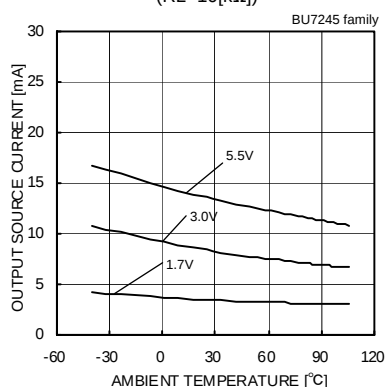


Fig.171
Output Source Current – Ambient Temperature
($V_{OUT}=V_{DD}-0.4[V]$)

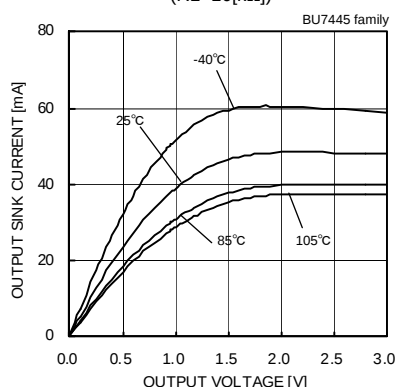


Fig.172
Output Sink Current – Output Voltage
($V_{DD}=3[V]$)

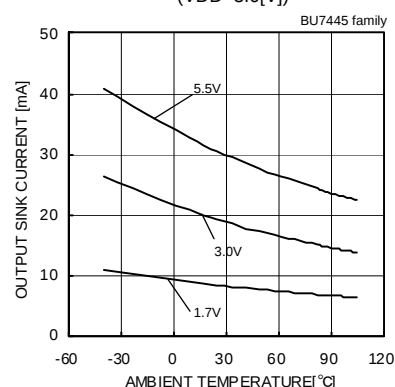


Fig.173
Output Sink Current – Ambient Temperature
($V_{OUT}=V_{SS}+0.4[V]$)

(*)The above data is ability value of sample, it is not guaranteed. BU7445HFV: -40[°C] ~ +85[°C] BU7445S HFV: -40[°C] ~ +105[°C]

●Reference data (BU7445 family)

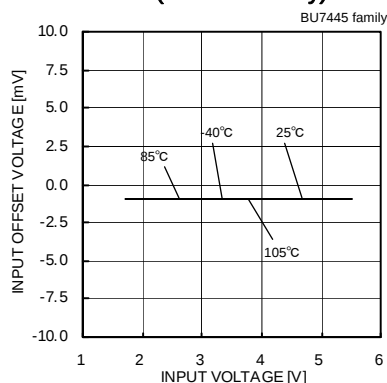


Fig.174
Input Offset Voltage – Supply Voltage
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

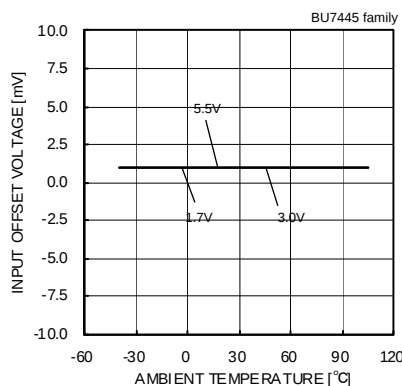


Fig.175
Input Offset Voltage – Ambient Temperature
($V_{icm} = V_{DD} - 1.2[V]$, $V_{OUT} = V_{DD}/2$)

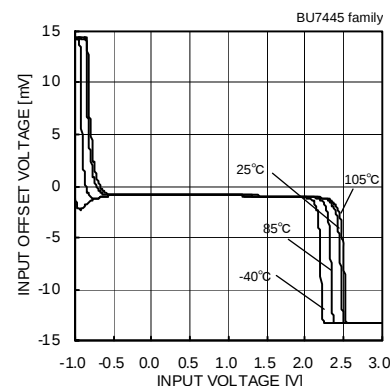


Fig.176
Input Offset Voltage – Input Voltage
($V_{DD} = 3[V]$)

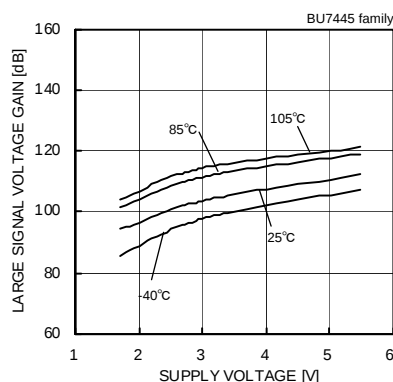


Fig.177
Large Signal Voltage Gain
– Supply Voltage

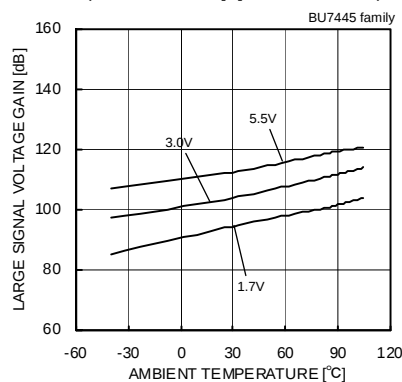


Fig.178
Large Signal Voltage Gain
– Ambient Temperature

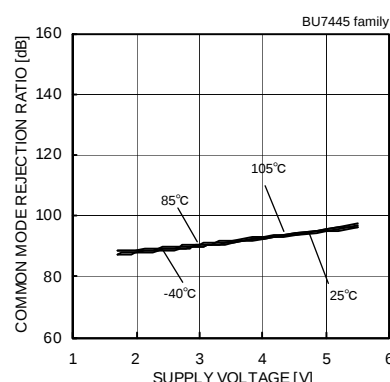


Fig.179
Common Mode Rejection Ratio
– Supply Voltage

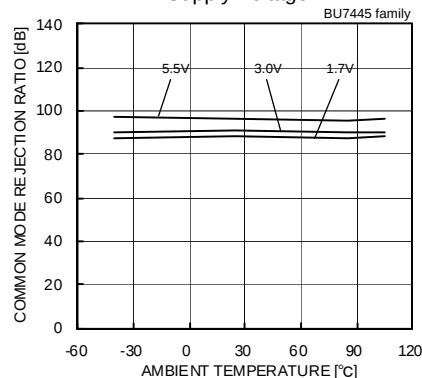


Fig.180
Common Mode Rejection Ratio
– Ambient Temperature

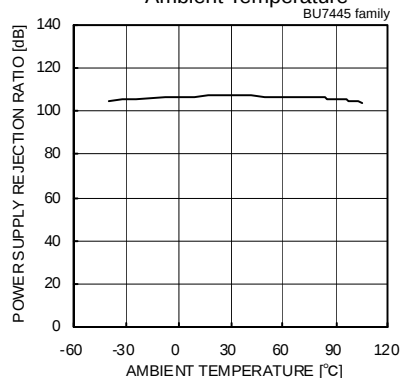


Fig.181
Power Supply Rejection Ratio
– Ambient Temperature

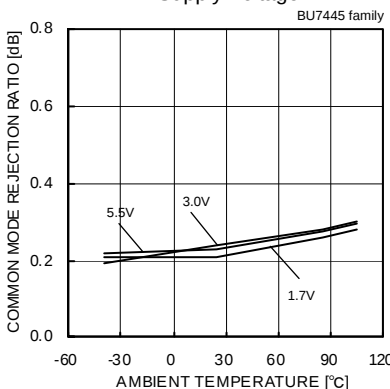


Fig.182
Slew Rate L-H – Ambient Temperature

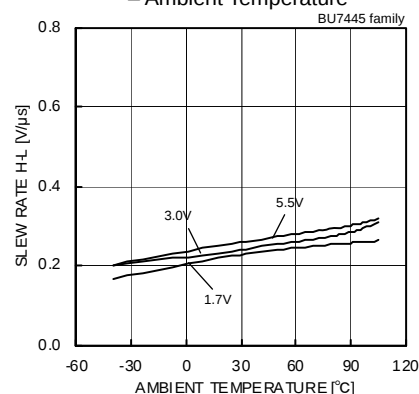


Fig.183
Slew Rate H-L – Ambient Temperature

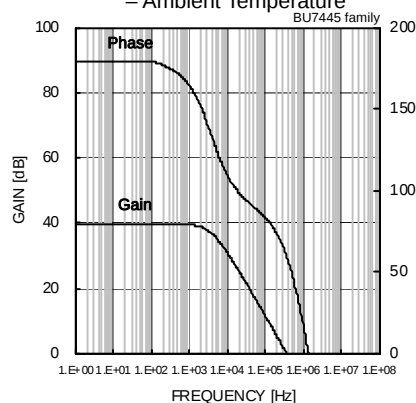


Fig.184
Gain – Frequency

(*)The above data is ability value of sample, it is not guaranteed. BU7445HFV: -40[°C] ~ +85[°C] BU7445S HFV: -40[°C] ~ +105[°C]

● Test circuit 1 NULL method

VDD, VSS, EK, Vicm Unit:[V]

Parameter	VF	S1	S2	S3	VDD	VSS	EK	Vicm	Calculation
Input Offset Voltage	VF1	ON	ON	OFF	3	0	-1.5	1.8	1
Large Signal Voltage Gain	VF2	ON	ON	ON	3	0	-0.5	0.9	2
	VF3						-2.5		
Common-mode Rejection Ratio (Input Common-mode Voltage Range)	VF4	ON	ON	OFF	3	0	-1.5	0	3
	VF5						-1.5	1.8	
Power Supply Rejection Ratio	VF6	ON	ON	OFF	1.7	0	-0.9	0	4
	VF7				5.5				

— Calculation —

1. Input Offset Voltage (Vio)

$$V_{io} = \frac{|VF1|}{1 + R_f/R_s} [V]$$

2. Large Signal Voltage Gain(Av)

$$A_v = 20\text{Log} \frac{2 \times (1 + R_f/R_s)}{|VF2-VF3|} [dB]$$

3. Common-mode Rejection Ratio (CMRR)

$$\text{CMRR} = 20\text{Log} \frac{1.8 \times (1 + R_f/R_s)}{|VF4 - VF5|} [dB]$$

4. Power Supply Rejection Ratio (PSRR)

$$\text{PSRR} = 20\text{Log} \frac{3.8 \times (1 + R_f/R_s)}{|VF6 - VF7|} [dB]$$

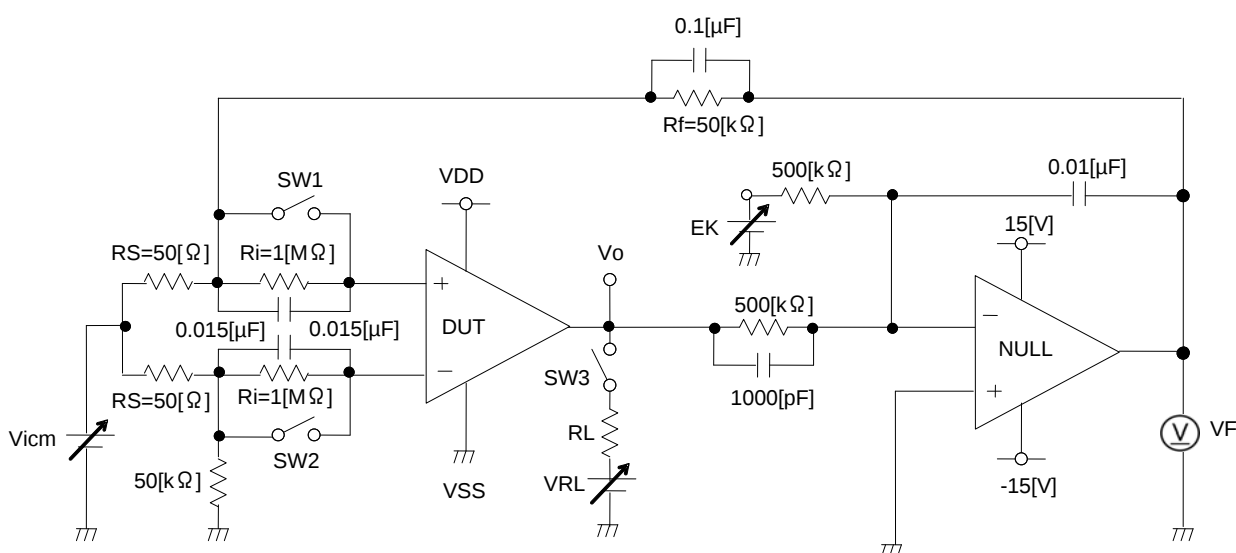


Fig.185 Test circuit 1 (one channel only)

●Test circuit 2 switch condition

SW No.	SW 1	SW 2	SW 3	SW 4	SW 5	SW 6	SW 7	SW 8	SW 9	SW 10	SW 11	SW 12
Supply Current	OFF	OFF	ON	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF
Maximum Output Voltage RL=10 [kΩ]	OFF	ON	OFF	OFF	ON	OFF	OFF	ON	OFF	OFF	ON	OFF
Output Current	OFF	ON	OFF	OFF	ON	OFF	OFF	OFF	OFF	ON	OFF	OFF
Slew Rate	OFF	OFF	ON	OFF	OFF	OFF	ON	OFF	ON	OFF	OFF	ON
Maximum Frequency	ON	OFF	OFF	ON	ON	OFF	OFF	OFF	ON	OFF	OFF	ON

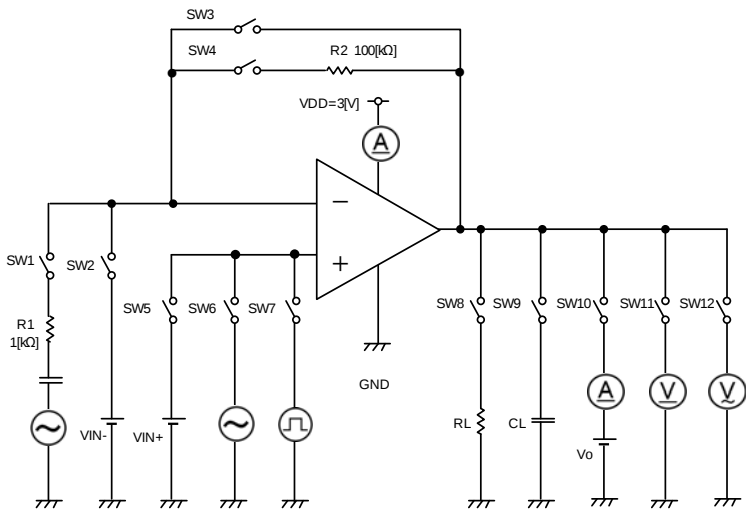


Fig.186 Test circuit 2

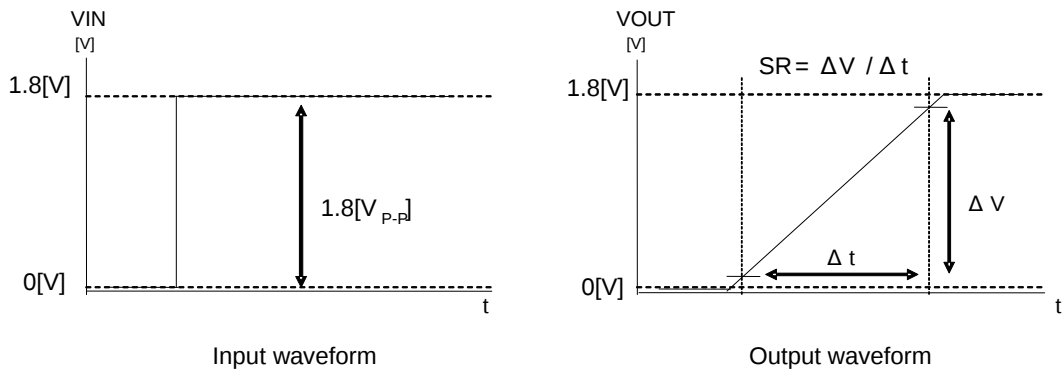


Fig.187 Slew rate input output wave

● Test circuit 3 Channel separation

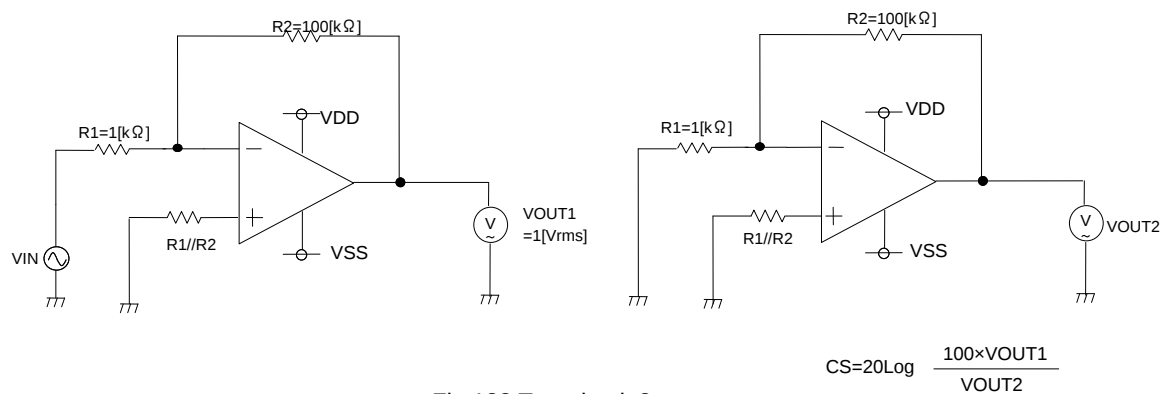


Fig.188 Test circuit 3

● Schematic diagram

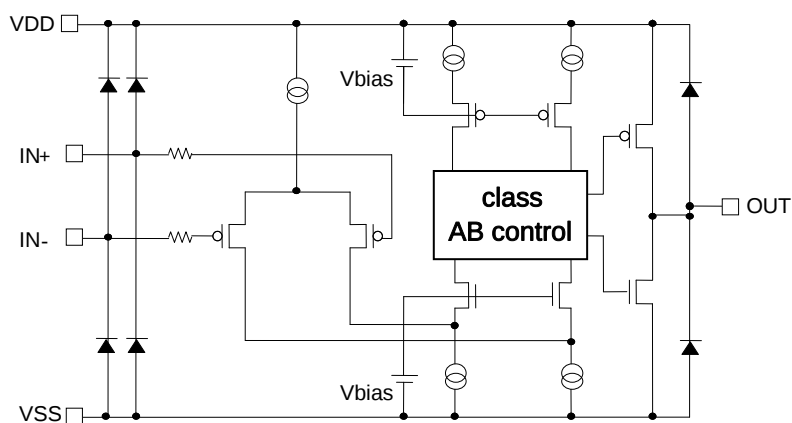
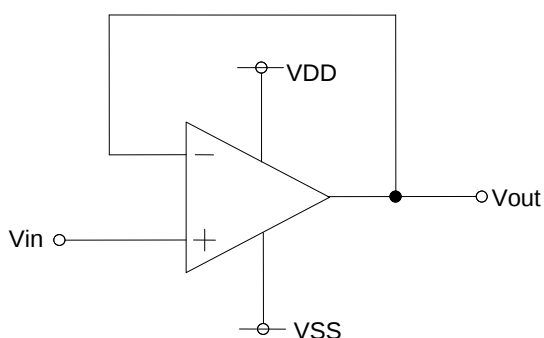


Fig.189 Schematic diagram

●Examples of circuit

○Voltage follower



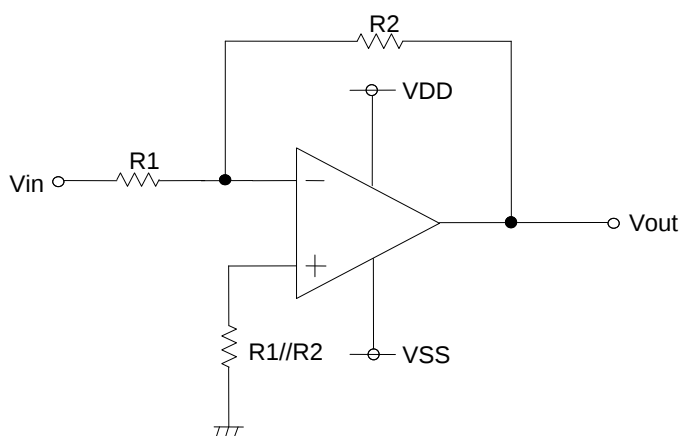
Voltage gain is 0 [dB].

This circuit controls output voltage (Vout) equal input voltage (Vin), and keeps Vout with stable because of high input impedance and low output impedance. Vout is shown next formula.

$$V_{out} = V_{in}$$

Fig.190 Voltage follower

○Inverting amplifier



For inverting amplifier, Vin is amplified by voltage gain decided R1 and R2, and phase reversed voltage is outputted.

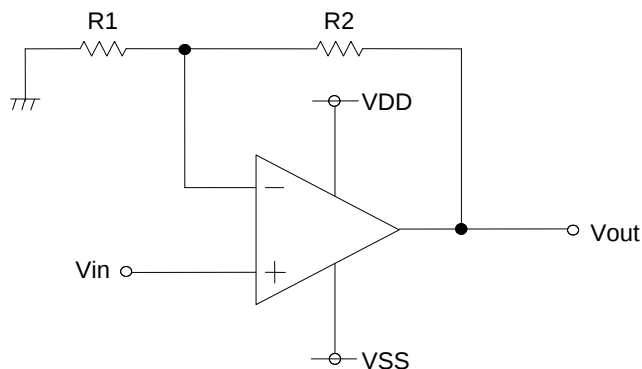
Vout is shown next formula.

$$V_{out} = -(R_2/R_1) \cdot V_{in}$$

Input impedance is R1.

Fig.191 Inverting amplifier

○Non-inverting amplifier



For non-inverting amplifier, Vin is amplified by voltage gain decided R1 and R2, and phase is same with Vin. Vout is shown next formula.

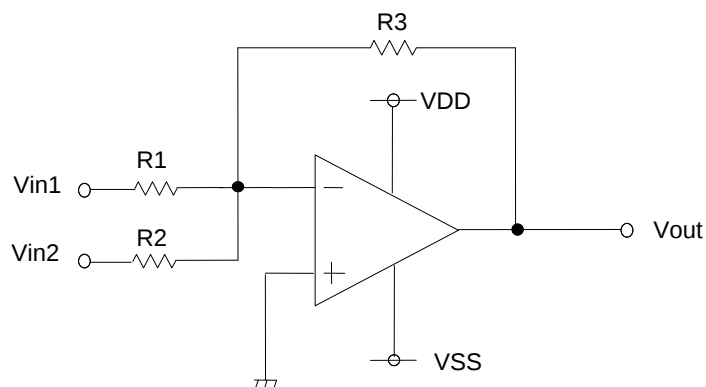
$$V_{out} = (1 + R_2/R_1) \cdot V_{in}$$

This circuit realizes high input impedance because Input impedance is operational amplifier's input Impedance.

Fig.192 Non-inverting amplifier

● Examples of circuit

○ Adder circuit



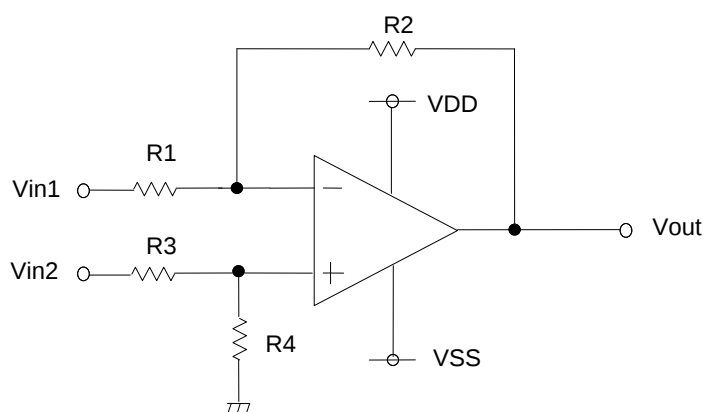
Adder circuit output the voltage that added up Input voltage. A phase of the output voltage turns over, because non-inverting circuit is used.
 Vout is shown next formula.

$$V_{out} = -R3(V_{in1}/R1 + V_{in2}/R2)$$

When three input voltage is as above, it connects with input through resistance like R1 and R2.

Fig.193 Adder circuit

○ Differential amplifier



Differential amplifier output the voltage that amplified a difference of input voltage.
 In the case of $R1=R3=R_a$, $R2=R4=R_b$
 Vout is shown next formula.

$$V_{out} = -R_b/R_a(V_{in1} - V_{in2})$$

Fig.194 Differential amplifier

●Description of electrical characteristics

Described here are the terms of electric characteristics used in this technical note. Items and symbols used are also shown. Note that item name and symbol and their meaning may differ from those on another manufacture's document or general document.

1. Absolute maximum ratings

Absolute maximum rating item indicates the condition which must not be exceeded. Application of voltage in excess of absolute maximum rating or use out of absolute maximum rated temperature environment may cause deterioration of characteristics.

1.1 Power supply voltage (VDD/VSS)

Indicates the maximum voltage that can be applied between the positive power supply terminal and negative power supply terminal without deterioration or destruction of characteristics of internal circuit.

1.2 Differential input voltage (Vid)

Indicates the maximum voltage that can be applied between non-inverting terminal and inverting terminal without deterioration and destruction of characteristics of IC.

1.3 Input common-mode voltage range (Vicm)

Indicates the maximum voltage that can be applied to non-inverting terminal and inverting terminal without deterioration or destruction of characteristics. Input common-mode voltage range of the maximum ratings not assures normal operation of IC. When normal Operation of IC is desired, the input common-mode voltage of characteristics item must be followed.

1.4 Power dissipation (Pd)

Indicates the power that can be consumed by specified mounted board at the ambient temperature 25°C(normal temperature). As for package product, Pd is determined by the temperature that can be permitted by IC chip in the package (maximum junction temperature) and thermal resistance of the package.

2. Electrical characteristics item

2.1 Input offset voltage (Vio)

Indicates the voltage difference between non-inverting terminal and inverting terminal. It can be translated into the input voltage difference required for setting the output voltage at 0 [V].

2.2 Input offset current (Iio)

Indicates the difference of input bias current between non-inverting terminal and inverting terminal.

2.3 Input bias current (Ib)

Indicates the current that flows into or out of the input terminal. It is defined by the average of input bias current at non-inverting terminal and input bias current at inverting terminal.

2.4 Circuit current (ICC)

Indicates the IC current that flows under specified conditions and no-load steady status.

2.5 High level output voltage / Low level output voltage (VOH/VOL)

Indicates the voltage range that can be output by the IC under specified load condition. It is typically divided into high-level output voltage and low-level output voltage. High-level output voltage indicates the upper limit of output voltage. Low-level output voltage indicates the lower limit.

2.6 Large signal voltage gain (AV)

Indicates the amplifying rate (gain) of output voltage against the voltage difference between non-inverting terminal and inverting terminal. It is normally the amplifying rate (gain) with reference to DC voltage.

$$A_v = (\text{Output voltage fluctuation}) / (\text{Input offset fluctuation})$$

2.7 Input common-mode voltage range (Vicm)

Indicates the input voltage range where IC operates normally.

2.8 Common-mode rejection ratio (CMRR)

Indicates the ratio of fluctuation of input offset voltage when in-phase input voltage is changed. It is normally the fluctuation of DC.

$$CMRR = (\text{Change of Input common-mode voltage}) / (\text{Input offset fluctuation})$$

2.9 Power supply rejection ratio (PSRR)

Indicates the ratio of fluctuation of input offset voltage when supply voltage is changed. It is normally the fluctuation of DC.

$$PSRR = (\text{Change of power supply voltage}) / (\text{Input offset fluctuation})$$

2.10 Channel separation (CS)

Indicates the fluctuation of input offset voltage or that of output voltage with reference to the change of output voltage of driven channel.

2.11 Slew rate (SR)

Indicates the time fluctuation ratio of voltage output when step input signal is applied.

2.12 Unity gain frequency (ft)

Indicates a frequency where the voltage gain of Op-Amp is 1.

2.13 Total harmonic distortion + Noise (THD+N)

Indicates the fluctuation of input offset voltage or that of output voltage with reference to the change of output voltage of driven channel.

2.14 Input referred noise voltage (Vn)

Indicates a noise voltage generated inside the operational amplifier equivalent by ideal voltage source connected in series with input terminal.

Derating curve

Power dissipation (total loss) indicates the power that can be consumed by IC at $T_a=25^{\circ}\text{C}$ (normal temperature). IC is heated when it consumed power, and the temperature of IC chip becomes higher than ambient temperature. The temperature that can be accepted by IC chip depends on circuit configuration, manufacturing process, and consumable power is limited. Power dissipation is determined by the temperature allowed in IC chip (maximum junction temperature) and thermal resistance of package (heat dissipation capability). The maximum junction temperature is typically equal to the maximum value in the storage package (heat dissipation capability). The maximum junction temperature is typically equal to the maximum value in the storage temperature range. Heat generated by consumed power of IC radiates from the mold resin or lead frame of the package. The parameter which indicates this heat dissipation capability (hardness of heat release) is called thermal resistance, represented by the symbol θ_{ja} [$^{\circ}\text{C}/\text{W}$]. The temperature of IC inside the package can be estimated by this thermal resistance. Fig.195 (a) shows the model of thermal resistance of the package. Thermal resistance θ_{ja} , ambient temperature T_a , junction temperature T_j , and power dissipation P_d can be calculated by the equation below:

$$\theta_{ja} = (T_j - T_a) / P_d \quad [^{\circ}\text{C}/\text{W}] \quad \dots \dots (1)$$

Derating curve in Fig.195(b) indicates power that can be consumed by IC with reference to ambient temperature. Power that can be consumed by IC begins to attenuate at certain ambient temperature. This gradient is determined by thermal resistance θ_{ja} . Thermal resistance θ_{ja} depends on chip size, power consumption, package, ambient temperature, package condition, wind velocity, etc even when the same of package is used. Thermal reduction curve indicates a reference value measured at a specified condition. Fig.196 (c)-(h) show a derating curve for an example Ground Sense Low Voltage Operation CMOS Operational Amplifiers series.

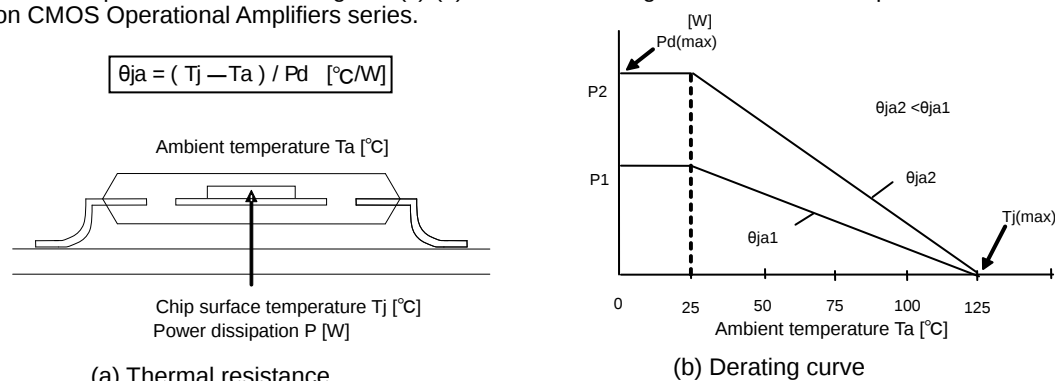
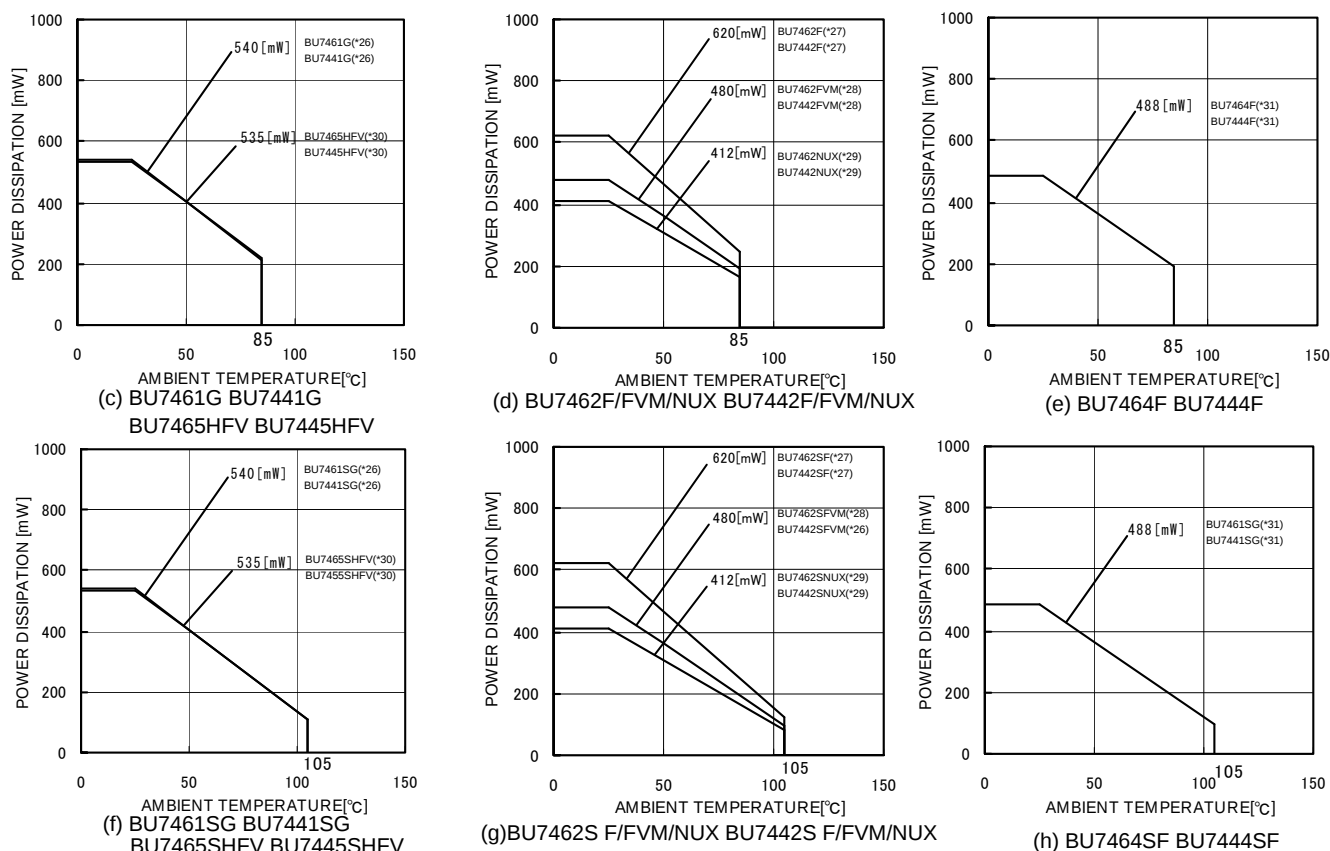


Fig.195 Thermal resistance and derating



(*26)	(*27)	(*28)	(*29)	(*30)	(*31)	Unit
5.4	6.2	4.8	4.12	5.35	4.88	[mW/°C]

When using the unit above $T_a=25^{\circ}\text{C}$, subtract the value above per degree $^{\circ}\text{C}$. Permissible dissipation is the value.

When FR4 glass epoxy board 70[mm]×70[mm]×1.6[mm] (copper foil area below 3[%]) is mounted.

Fig.196 Thermal resistance and derating

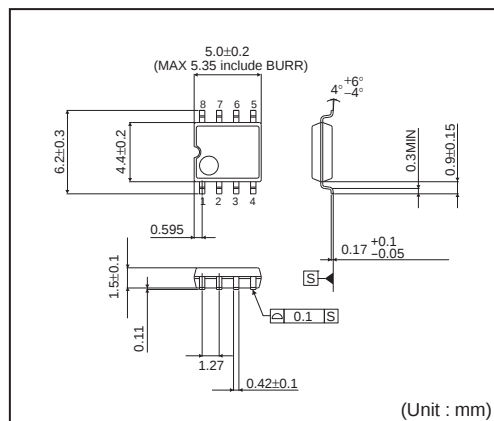
●Cautions on use

- 1) Absolute maximum ratings
Absolute maximum ratings are the values which indicate the limits, within which the given voltage range can be safely charged to the terminal. However, it does not guarantee the circuit operation.
- 2) Applied voltage to the input terminal
For normal circuit operation of voltage comparator, please input voltage for its input terminal within input common mode voltage $V_{DD} + 0.3[V]$. Then, regardless of power supply voltage, $V_{SS}-0.3[V]$ can be applied to input terminals without deterioration or destruction of its characteristics.
- 3) Operating power supply (split power supply/single power supply)
The voltage comparator operates if a given level of voltage is applied between V_{DD} and V_{SS} . Therefore, the operational amplifier can be operated under single power supply or split power supply.
- 4) Power dissipation (pd)
If the IC is used under excessive power dissipation. An increase in the chip temperature will cause deterioration of the radical characteristics of IC. For example, reduction of current capability. Take consideration of the effective power dissipation and thermal design with a sufficient margin. Pd is reference to the provided power dissipation curve.
- 5) Short circuits between pins and incorrect mounting
Short circuits between pins and incorrect mounting when mounting the IC on a printed circuits board, take notice of the direction and positioning of the IC. If IC is mounted erroneously, It may be damaged. Also, when a foreign object is inserted between output, between output and V_{DD} terminal and V_{SS} terminal which causes short circuit, the IC may be damaged.
- 6) Using under strong electromagnetic field
Be careful when using the IC under strong electromagnetic field because it may malfunction.
- 7) Usage of IC
When stress is applied to the IC through warp of the printed circuit board, The characteristics may fluctuate due to the piezo effect. Be careful of the warp of the printed circuit board.
- 8) Testing IC on the set board
When testing IC on the set board, in cases where the capacitor is connected to the low impedance, make sure to discharge per fabrication because there is a possibility that IC may be damaged by stress. When removing IC from the set board, it is essential to cut supply voltage. As a countermeasure against the static electricity, observe proper grounding during fabrication process and take due care when carrying and storage it.
- 9) The IC destruction caused by capacitive load
The transistors in circuits may be damaged when V_{DD} terminal and V_{SS} terminal is shorted with the charged output terminal capacitor. When IC is used as a operational amplifier or as an application circuit, where oscillation is not activated by an output capacitor, the output capacitor must be kept below $0.1[\mu F]$ in order to prevent the damage mentioned above.
- 10) Latch up
Be careful of input voltage that exceed the V_{DD} and V_{SS} . When CMOS device have sometimes occur latch up operation. And protect the IC from abnormaly noise
- 11) Decoupling capacitor
Insert the decoupling capacitance between V_{DD} and V_{SS} , for stable operation of operational amplifier.

●Ordering part number

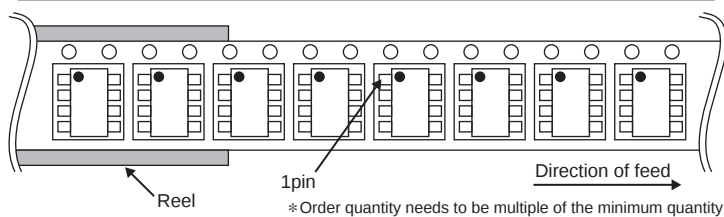
B	U	7	4	6	2	S	F	V	M	-	T	R
Part No.		Part No.					Package				Packaging and forming specification	
		• 7461 7461S • 7464 7464S • 7441 7441S • 7444 7444S • 7462 7462S • 7465 7465S • 7442 7442S • 7445 7445S					G : SSOP5 F : SOP8, SOP14 FVM : MSOP8 NUX : VSON008X2030 HFV : HVSOF5				E2: Embossed tape and reel (SOP8/SOP14) TR: Embossed tape and reel (SSOP5/MSOP8/VSON008X2030/HVSOF5)	

SOP8

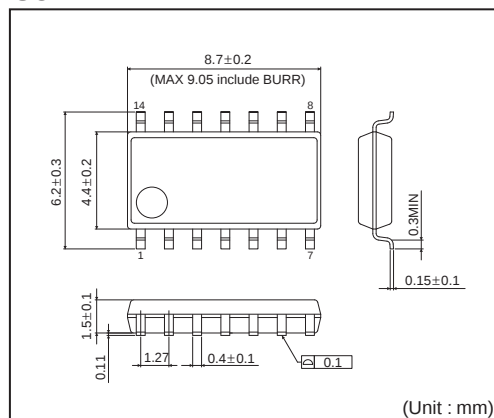


<Tape and Reel information>

Tape	Embossed carrier tape
Quantity	2500pcs
Direction of feed	E2 (The direction is the 1pin of product is at the upper left when you hold reel on the left hand and you pull out the tape on the right hand)

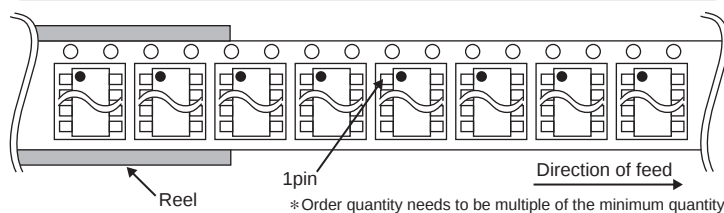


SOP14

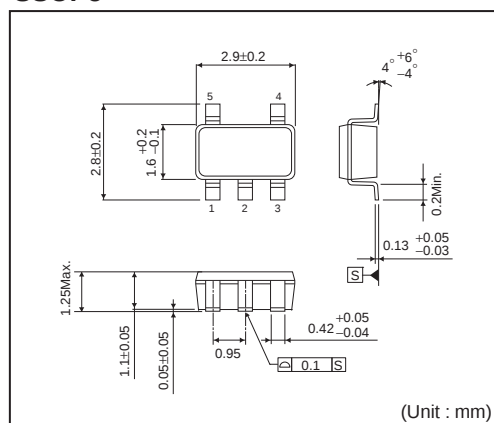


<Tape and Reel information>

Tape	Embossed carrier tape
Quantity	2500pcs
Direction of feed	E2 (The direction is the 1pin of product is at the upper left when you hold reel on the left hand and you pull out the tape on the right hand)

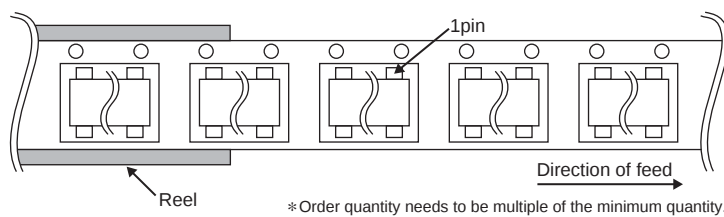


SSOP5



<Tape and Reel information>

Tape	Embossed carrier tape
Quantity	3000pcs
Direction of feed	TR (The direction is the 1pin of product is at the upper right when you hold reel on the left hand and you pull out the tape on the right hand)



Notice

Precaution on using ROHM Products

- Our Products are designed and manufactured for application in ordinary electronic equipments (such as AV equipment, OA equipment, telecommunication equipment, home electronic appliances, amusement equipment, etc.). If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment ^(Note 1), transport equipment, traffic equipment, aircraft/spacecraft, nuclear power controllers, fuel controllers, car equipment including car accessories, safety devices, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

(Note1) Medical Equipment Classification of the Specific Applications

JAPAN	USA	EU	CHINA
CLASS III	CLASS III	CLASS II b	CLASS III
CLASS IV		CLASS III	

- ROHM designs and manufactures its Products subject to strict quality control system. However, semiconductor products can fail or malfunction at a certain rate. Please be sure to implement, at your own responsibilities, adequate safety measures including but not limited to fail-safe design against the physical injury, damage to any property, which a failure or malfunction of our Products may cause. The following are examples of safety measures:
 - Installation of protection circuits or other protective devices to improve system safety
 - Installation of redundant circuits to reduce the impact of single or multiple circuit failure
- Our Products are designed and manufactured for use under standard conditions and not under any special or extraordinary environments or conditions, as exemplified below. Accordingly, ROHM shall not be in any way responsible or liable for any damages, expenses or losses arising from the use of any ROHM's Products under any special or extraordinary environments or conditions. If you intend to use our Products under any special or extraordinary environments or conditions (as exemplified below), your independent verification and confirmation of product performance, reliability, etc. prior to use, must be necessary:
 - Use of our Products in any types of liquid, including water, oils, chemicals, and organic solvents
 - Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
 - Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl₂, H₂S, NH₃, SO₂, and NO₂
 - Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
 - Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
 - Sealing or coating our Products with resin or other coating materials
 - Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
 - Use of the Products in places subject to dew condensation
- The Products are not subject to radiation-proof design.
- Please verify and confirm characteristics of the final or mounted products in using the Products.
- In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- Confirm that operation temperature is within the specified range described in the product specification.
- ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

Precaution for Mounting / Circuit board design

- When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

Precautions Regarding Application Examples and External Circuits

1. If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
2. You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

Precaution for Electrostatic

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of ionizer, friction prevention and temperature / humidity control).

Precaution for Storage / Transportation

1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
 - [a] the Products are exposed to sea winds or corrosive gases, including Cl₂, H₂S, NH₃, SO₂, and NO₂
 - [b] the temperature or humidity exceeds those recommended by ROHM
 - [c] the Products are exposed to direct sunshine or condensation
 - [d] the Products are exposed to high Electrostatic
2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

Precaution for Product Label

QR code printed on ROHM Products label is for ROHM's internal use only.

Precaution for Disposition

When disposing Products please dispose them properly using an authorized industry waste company.

Precaution for Foreign Exchange and Foreign Trade act

Since our Products might fall under controlled goods prescribed by the applicable foreign exchange and foreign trade act, please consult with ROHM representative in case of export.

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